

# TEST REPORT

FROM



FOR

Applied Wireless ID Group, Inc.

RFID Reader

Model: MPR-3014WF

TO

47 CFR 15.247:2005 & RSS-210 Issue 6:2005


Test Report Serial No.:  
SL06042601-AWID-005/02

This report supersedes None

**Remarks:**      Equipment complied with the specification      ☒   
                      Equipment did not comply with the specification      ☐

**This Test Report is Issued Under the Authority of:**

  
.....  
Tested by: Kerwinn Corpuz, Test Engineer

  
.....  
Reviewed by: Leslie Bai, Lab Manager

Issue date: 19 July 2006  
Manufacturer: Applied Wireless ID Group, Inc.



Registration No. 783147



Industry Canada  
Industrie Canada

Registration No. 4842



Lab Code: KR0032



RTA No. D23/16V



NVLAP Lab Code: 200729-0

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**FCCID:** OGSR32EA031

**To:** 47 CFR 15.247:2005 & RSS-210 Issue  
6:2005

**Serial#** SL06042601-AWID-005/02

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## **Executive Summary**

The purpose of this test programme was to demonstrate compliance of the Applied Wireless ID Group, Inc., RFID Reader, model MPR-3014WF against the current 47 CFR 15.247:2005 & RSS-210 Issue 6:2005. The RFID Reader contains MPR-1510R3.2E module. The MPR-3014WF demonstrated compliance with the 47 CFR 15.247:2005 & RSS-210 Issue 6:2005.

Applied Wireless ID Group, Inc. is the applicant and claimed manufacturer of this tested product. For the detailed description of this product, please refer to the MPR-3014WF User Manual.

The equipment under test is a frequency hopping system operating in the 902-928MHz band.

The equipment was tested with six protocols:

- 1) GEN-2 = EPC Class1 Generation2
- 2) ISOB = ISO18000-6 Type B
- 3) Class-1 = EPC Class1
- 4) Class-0 = EPC Class 0/0+
- 5) EPC1.19 = EPC V1.19 Rev.2

The equipment was tested with the following antenna:

AWID, model ANT-915CPS-A; 5.7 dBi Circular polarized antenna (Patch)

The test has demonstrated that this unit complies with stipulated standards.



FRONT



BACK

RFID Reader Sample



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## **1 Technical Details**

Purpose	Compliance testing of MPR-3014WF with 47 CFR 15.247:2005 & RSS-210 Issue 6:2005
Applicant / Client	Applied Wireless ID Group, Inc. 18300 Sutter Blvd. Morgan Hill, CA 95037
Manufacturer	Applied Wireless ID Group, Inc. 18300 Sutter Blvd. Morgan Hill, CA 95037
Laboratory performing the tests	SIEMIC Labs 2206 Ringwood Avenue San Jose, CA 95131
Test location(s)	SIEMIC Labs 2206 Ringwood Avenue San Jose, CA 95131
Test report reference number	SL06042601-AWID-005/02
Date EUT received	28 April 2006
Standard applied	47 CFR 15.247:2005 & RSS-210 Issue 6:2005
Dates of test (from – to)	28 April 2006 to 05 June 2006
No of Units:	1
Equipment Category:	DSS
Trade/Product Name:	MPR-3014WF
Type/Model Name/No:	MPR-3014WF
Technical Variants:	None
FCC ID No.	OGSR32EA031
IC ID No.	6449A-R32EA031

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## 2 Tests Required

The product was tested in accordance with the following specifications.

The test results recorded in this Test Report are exclusively referred to the tested sample(s).

Test Standard		Description	Pass / Fail
47 CFR Part 15.247: 2005	RSS 210 Issue6: 2005		
15.203		Antenna Requirement	Pass
15.205	RSS210(A8.5)	Restricted Band of Operation	Pass
15.207(a)	RSSGen(7.2.2)	Conducted Emissions Voltage	Pass
15.247(a)(1)	RSS210(A8.1)	Channel Separation	Pass
15.247(a)(1)	RSS210(A8.1)	Occupied Bandwidth	Pass
15.247(a)(1)	RSS210(A8.1)	Number of Hopping Channels	Pass
15.247(a)(1)	RSS210(A8.1)	Time of Occupancy	Pass
15.247(b)	RSS210(A8.4)	Output Power	Pass
15.247(c)	RSS210(A8.4)	Antenna Gain > 6 dBi	N/A
15.247(d)	RSS210(A8.5)	Conducted Spurious Emissions	Pass
15.209; 15.247(d)	RSS210(A8.5)	Radiated Spurious Emissions	Pass
15.247(e)	RSS210(A8.3)	Power Spectral Density	N/A*
15.247(f)	RSS210(A8.3)	Hybrid System Requirement	N/A*
15.247(g)	RSS210(A8.1)	Hopping Capability	Pass
15.247(h)	RSS210(A8.1)	Hopping Coordination Requirement	Pass
15.247(i)	RSSGen(5.5)	Maximum Permissible Exposure	Pass
	RSSGen(4.8)	Receiver Spurious Emissions	Pass
ANSI C63.4: 2003			

*Notes: Deviations to above standards are outlined in specific test sections if applicable.*

*Cable loss and external attenuation are compensated for in the measurement system when applicable.*

*\* Equipment is a Frequency Hopping System.*

### **3 Antenna Requirement**

**Requirement(s):** 47 CFR §15.203

An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device.

Antenna requirement must meet at least one of the following:

- a) Antenna must be permanently attached to the device.
- b) Antenna must use a unique type of connector to attach to the device.
- c) Device must be professionally installed. Installer shall be responsible for ensuring that the correct antenna is employed with the device.

The antenna has its own unique type of connector which meets the requirement.

- 1) AWID, model ANT-915CPS-A; 5.7 dBi Circular polarized antenna (Patch) with reversed polarity TNC.



Front Side



Back Side





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## **4 Measurements, Examinations and Derived Results**

### **4.1 General observations**

Equipment serial number(s)		
Module:	Part number:	Serial number:
MPR-3014WF	MPR-3014WF	none

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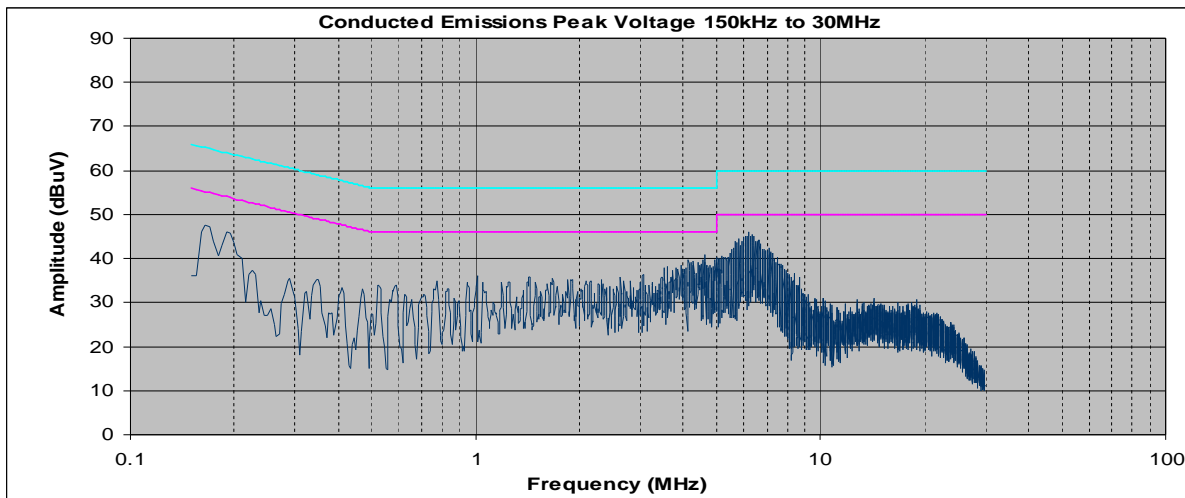
## 4.2 Test Results

### 4.2.1 Conducted Emissions Voltage

**Requirement(s):** 47 CFR §15.207 & RSS-Gen Issue 1(7.2.2)**Procedures:**

The EUT and supporting equipment were set up in accordance with the requirements of the standard on top of a 1.5m x 1m x 0.8m high, non-metallic table. The power supply for the EUT was fed through a 50Ω/50μH EUT LISN, connected to filtered mains. The RF OUT of the EUT LISN was connected to the EMI test receiver via a low-loss coaxial cable. All other supporting equipment were powered separately from another mains.

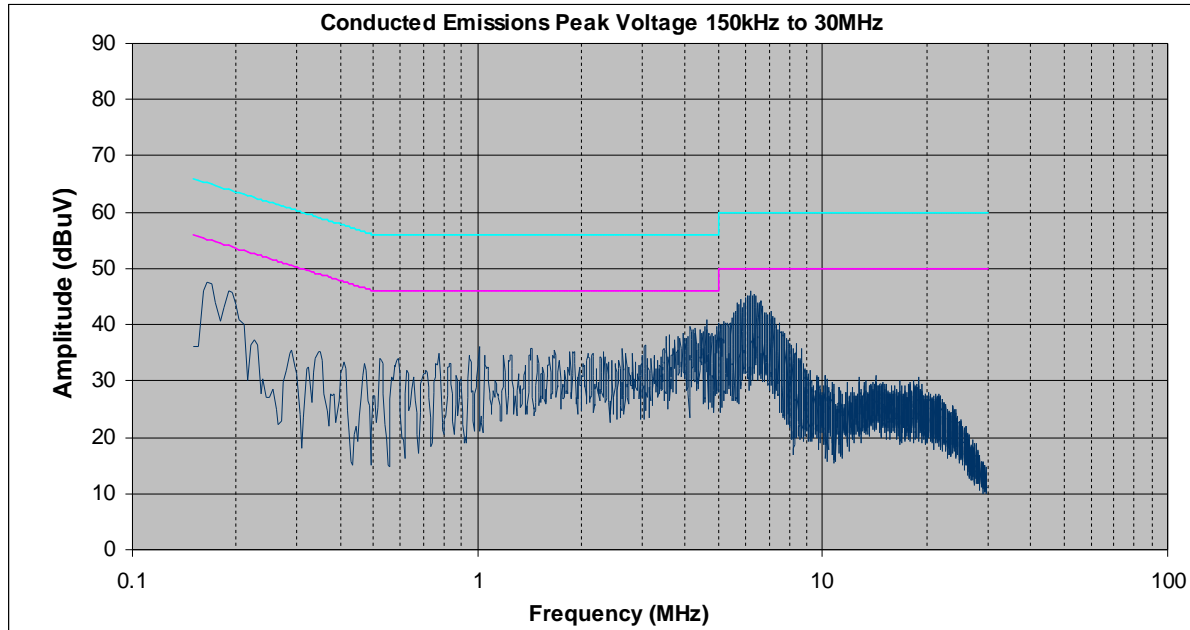
The EUT was switched on and allowed to warm up to its normal operating condition. The EUT was set to frequency hopping mode. Preliminary test were made to five protocols with the worse case protocol (EPC C0) reported. A scan was made on the NEUTRAL line over the required frequency range using an EMI test receiver. High peaks, relative to the limit line, were then selected. The EMI test receiver was then tuned to the selected frequencies and the necessary measurements made with a receiver bandwidth setting of 10kHz. Quasi-peak and Average measurements were made. The procedure was then repeated for the PHASE line.

**Results: Note – measurement between Tx and Rx are no different to emissions.**

**Neutral Line Plot at 120Vac, 60Hz**

FREQ. (MHz)	Corrected Amplitude (dBuV) PK	Limit (dBuV) QP	Margin (dB) QP	Corrected Amplitude (dBuV) PK	Limit (dBuV) AVG	Margin (dB) AVG
0.165	47.6	65.21	-17.61	47.6	55.21	-7.61
4.625	40.9	56	-15.1	40.9	46	-5.1
6.185	46	60	-14	46	50	-4

**Neutral Line Table**

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**Phase Line Plot at 120Vac, 60Hz**

<b>FREQ. (MHz)</b>	<b>Corrected Amplitude (dBuV) PK</b>	<b>Limit (dBuV) QP</b>	<b>Margin (dB) QP</b>	<b>Corrected Amplitude (dBuV) PK</b>	<b>Limit (dBuV) AVG</b>	<b>Margin (dB) AVG</b>
0.17	49	64.96	-15.96	49	54.96	-5.96
4.015	39.8	56	-16.2	39.8	46	-6.2
6.115	45.6	60	-14.4	45.6	50	-4.4

**Phase Line Table**

**Tested By:** Kerwinn Corpuz**Date Tested:** 28 April and 30 May 2006

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#### 4.2.2 Occupied Bandwidth

**Requirement(s):** 47 CFR §15.247(a)(1) & RSS-210 Issue 6(A8.1)**Procedures:** The 20dB bandwidths were measured conducted using a spectrum analyzer at low, mid, and hi channels. 20 dB Bandwidth Limit: < 500 kHz.**Results:**

Plot #	Protocol	Channel	Channel Frequency (MHz)	Occupied Bandwidth	Channel Bandwidth (kHz)
1	GEN-2	Low	902.75	20 dB	75.8
2	GEN-2	Mid	915.25	20 dB	75.8
3	GEN-2	High	927.25	20 dB	75.8
4	ISOB	Low	902.75	20 dB	85.17
5	ISOB	Mid	915.25	20 dB	84.67
6	ISOB	High	927.25	20 dB	85.17
7	CLASS-1	Low	902.75	20 dB	282.57
8	CLASS-1	Mid	915.25	20 dB	283.57
9	CLASS-1	High	927.25	20 dB	283.57
10	CLASS-0	Low	902.75	20 dB	152.5
11	CLASS-0	Mid	915.25	20 dB	152.5
12	CLASS-0	High	927.25	20 dB	153.3
13	EPC1.19	Low	902.75	20 dB	243.3
14	EPC1.19	Mid	915.25	20 dB	243.3
15	EPC1.19	High	927.25	20 dB	243.3

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Plot #	Protocol	Channel	Channel Frequency (MHz)	Occupied Bandwidth	Channel Bandwidth (kHz)
A	GEN-2	Low	902.75	99%	274.2
B	GEN-2	Mid	915.25	99%	271.7
C	GEN-2	High	927.25	99%	271.7
D	ISOB	Low	902.75	99%	353.71
E	ISOB	Mid	915.25	99%	331.66
F	ISOB	High	927.25	99%	327.66
G	CLASS-1	Low	902.75	99%	419.84
H	CLASS-1	Mid	915.25	99%	418.84
I	CLASS-1	High	927.25	99%	419.84
J	CLASS-0	Low	902.75	99%	270.8
K	CLASS-0	Mid	915.25	99%	269.2
L	CLASS-0	High	927.25	99%	265
M	EPC1.19	Low	902.75	99%	311.7
N	EPC1.19	Mid	915.25	99%	318.3
O	EPC1.19	High	927.25	99%	318.3



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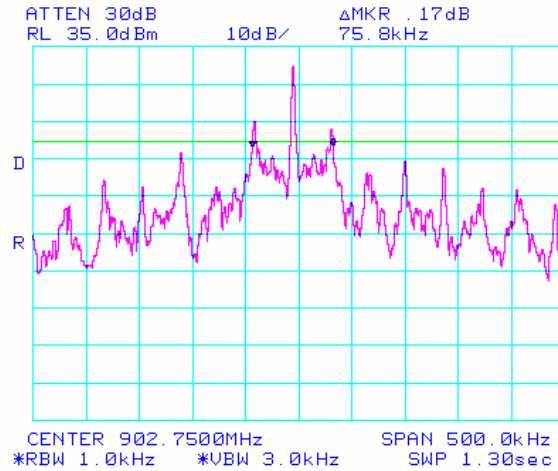
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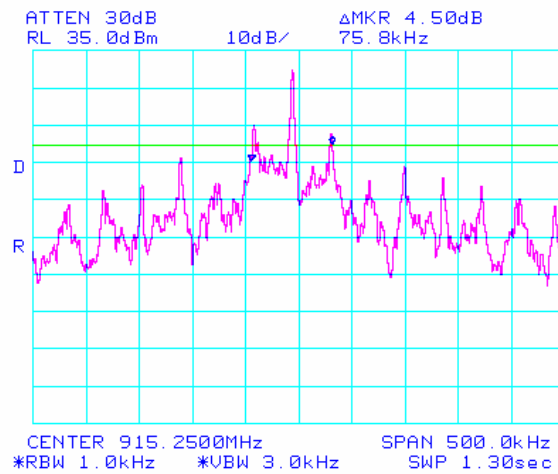
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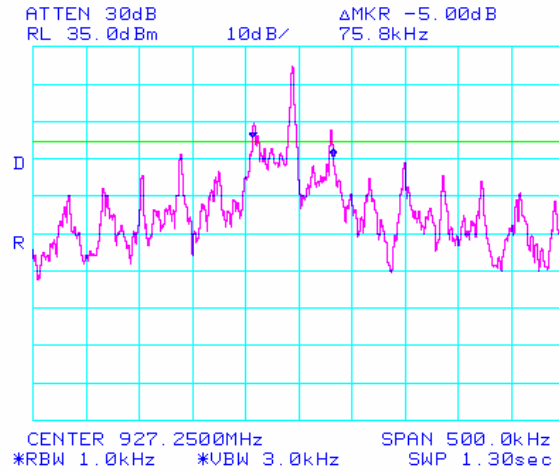
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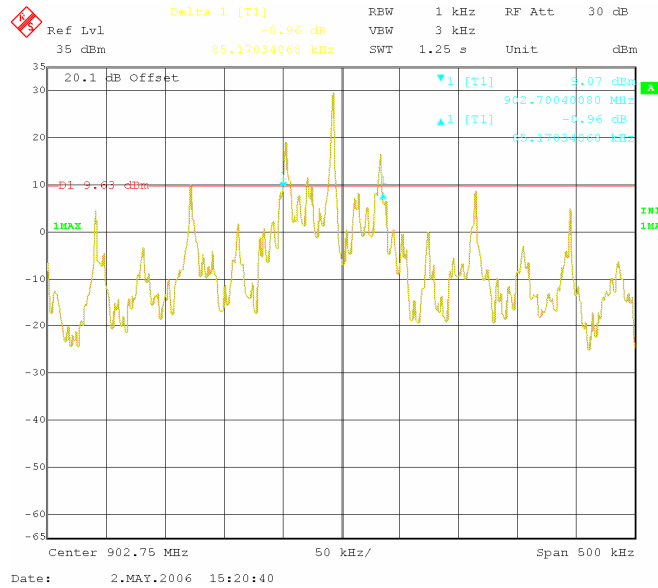
Plot 1: 20dB Bandwidth (Low) with GEN-2 protocol



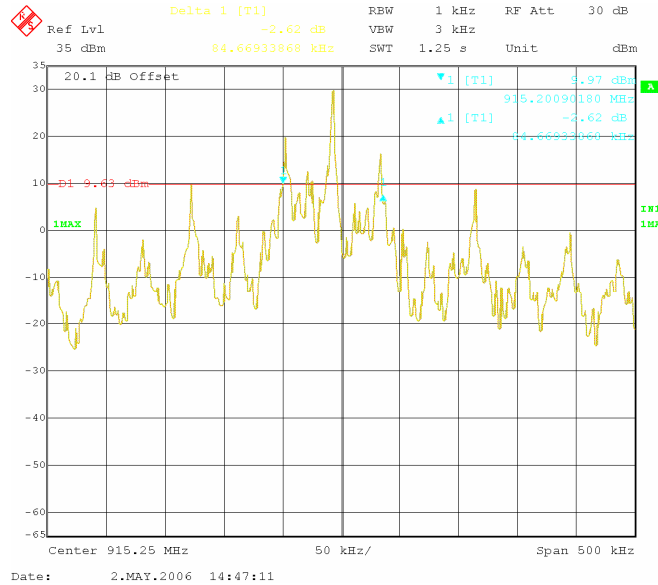
Plot 2: 20dB Bandwidth (Mid) with GEN-2 protocol



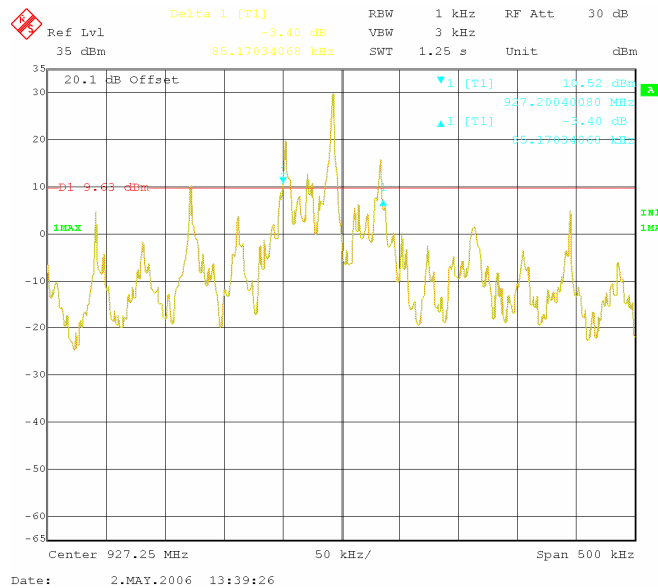
**Plot 3: 20dB Bandwidth (High) with GEN-2 protocol**



**Plot 4: 20dB Bandwidth (Low) with ISOB protocol**

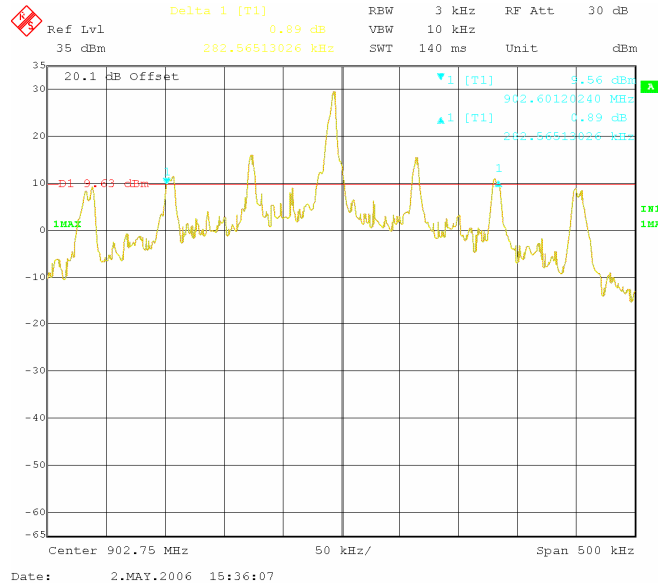


**Plot 5: 20dB Bandwidth (Mid) with ISOB protocol**

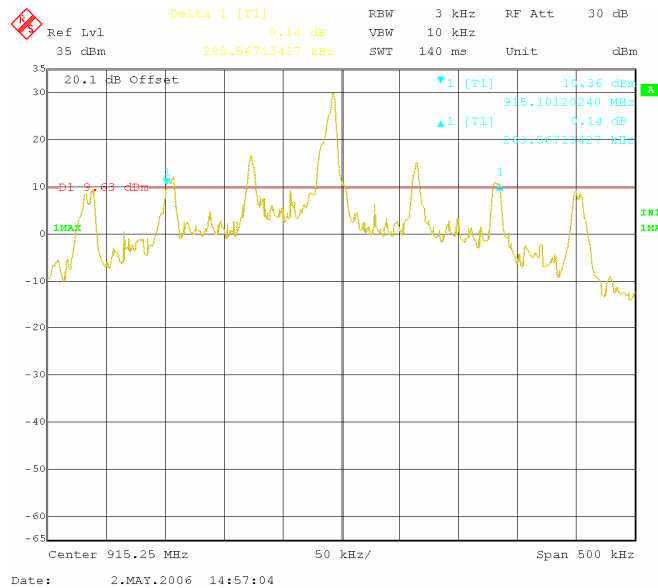


**Plot 6: 20dB Bandwidth (High) with ISOB protocol**

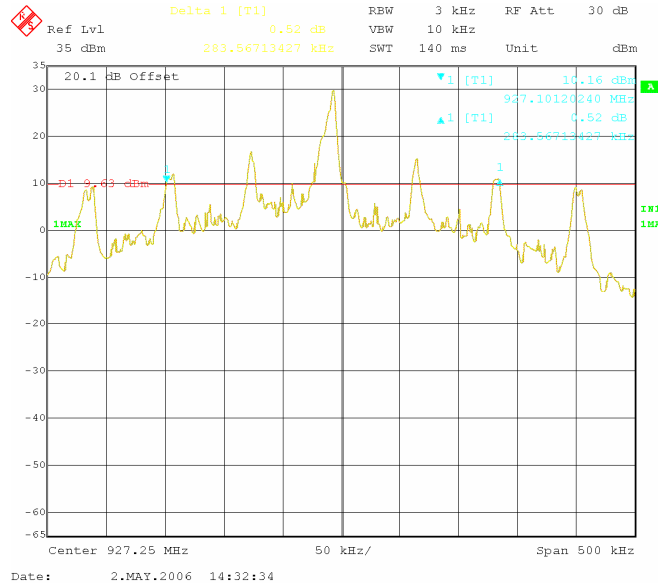




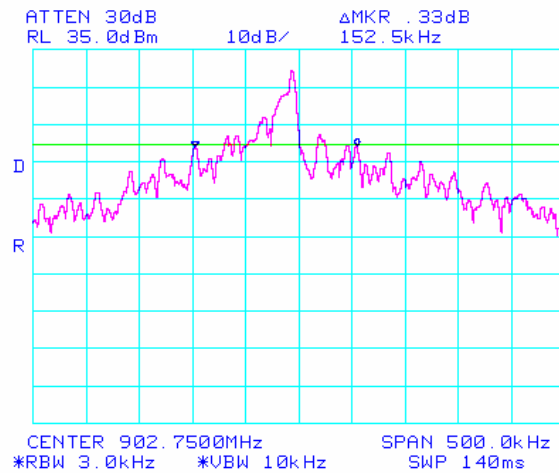
**Plot 7: 20dB Bandwidth (Low) with CLASS-1 protocol**



**Plot 8: 20dB Bandwidth (Mid) with CLASS-1 protocol**



**Plot 9: 20dB Bandwidth (High) with CLASS-1 protocol**



**Plot 10: 20dB Bandwidth (Low) with CLASS-0 protocol**

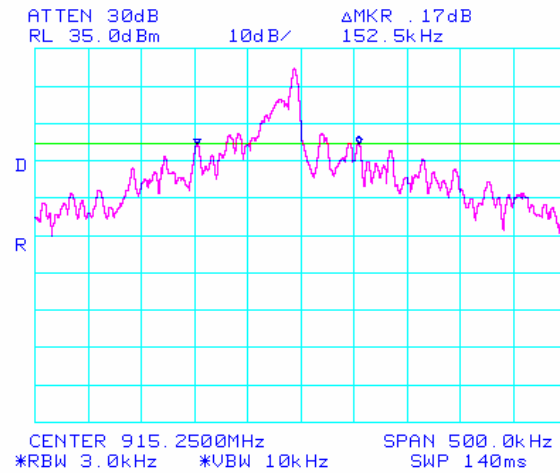


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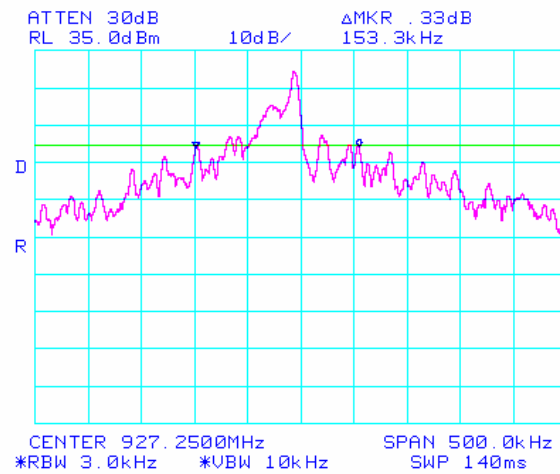
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Plot 11: 20dB Bandwidth (Mid) with CLASS-0 protocol



Plot 12: 20dB Bandwidth (High) with CLASS-0 protocol

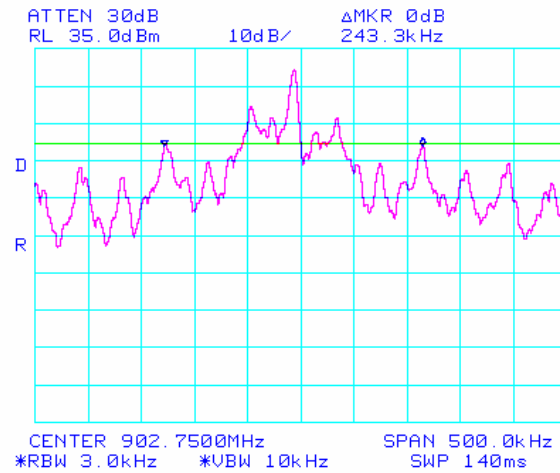


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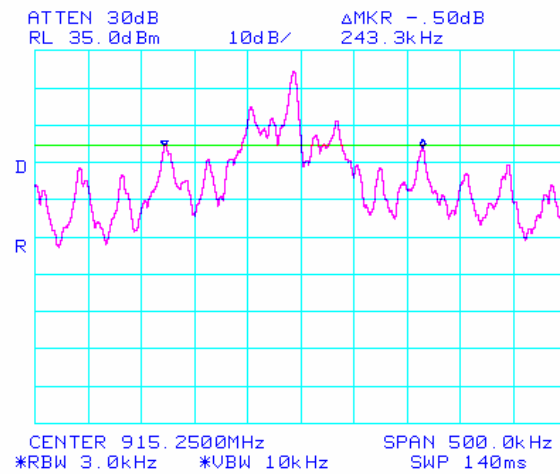
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Plot 13: 20dB Bandwidth (Low) with EPC1.19 protocol



Plot 14: 20dB Bandwidth (Mid) with EPC1.19 protocol



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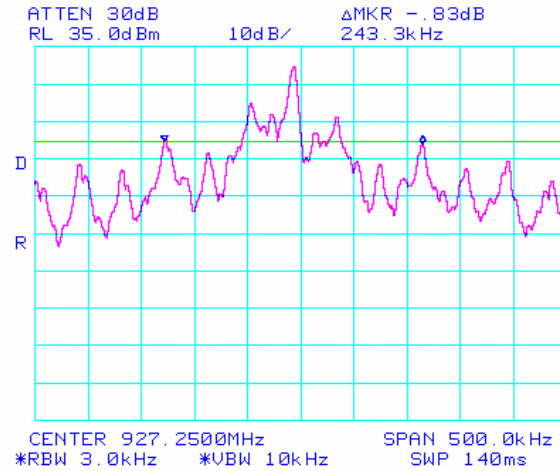
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Plot 15: 20dB Bandwidth (High) with EPC1.19 protocol



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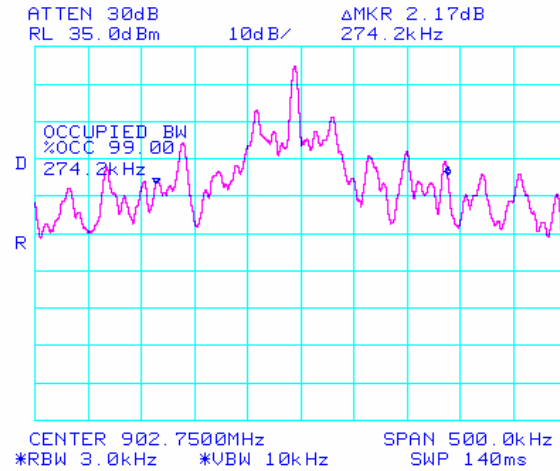
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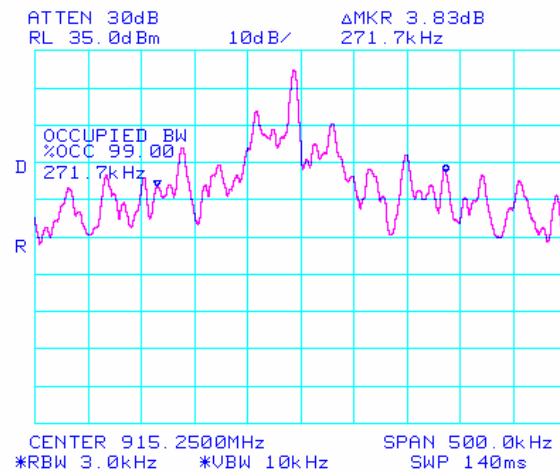
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Plot A: 99% Bandwidth (Low) with GEN-2 protocol



Plot B: 99% Bandwidth (Mid) with GEN-2 protocol

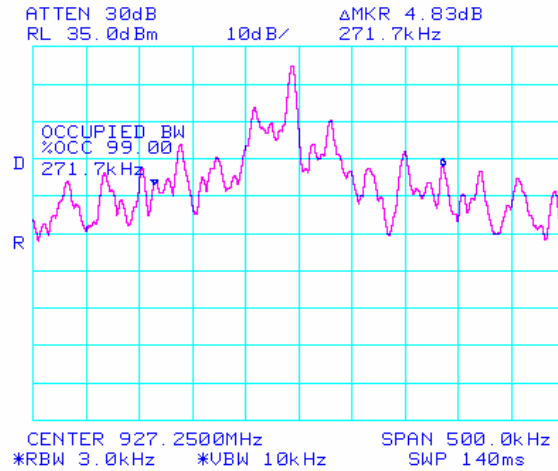


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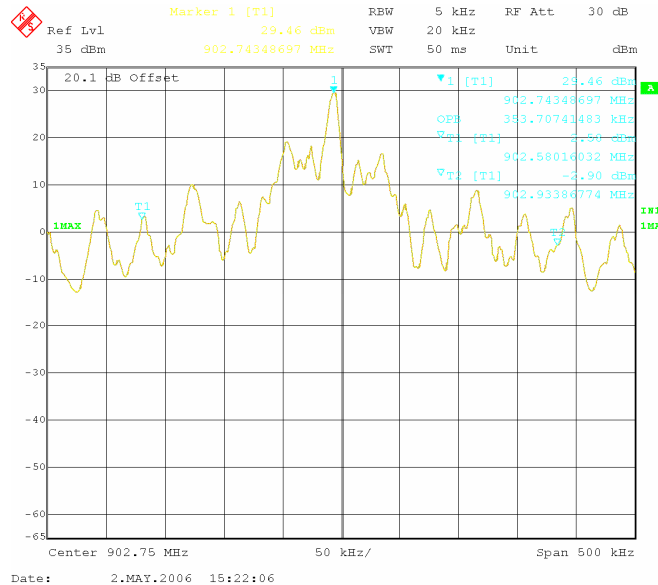
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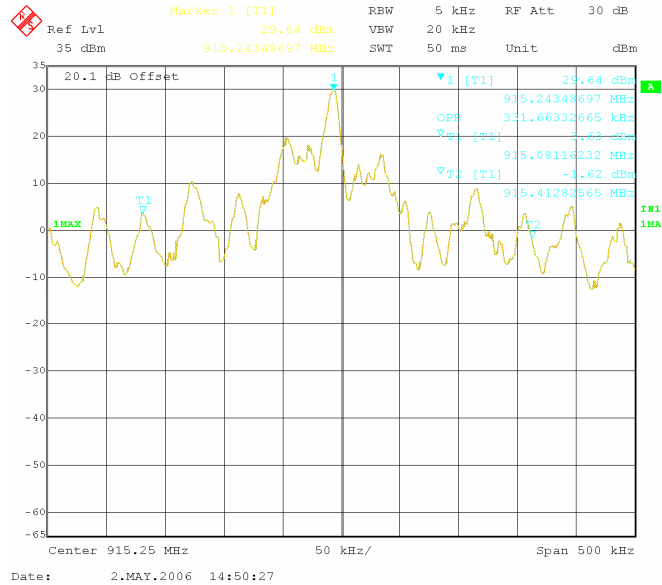
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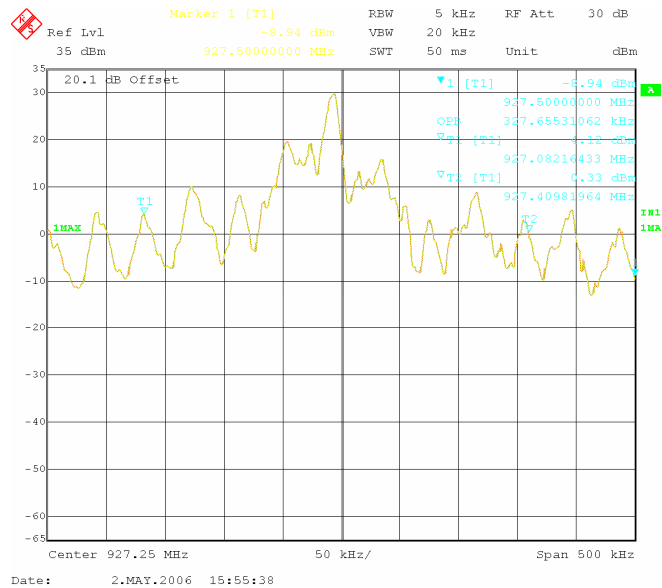
Plot C: 99% Bandwidth (High) with GEN-2 protocol



Plot D: 99% Bandwidth (Low) with ISOB protocol

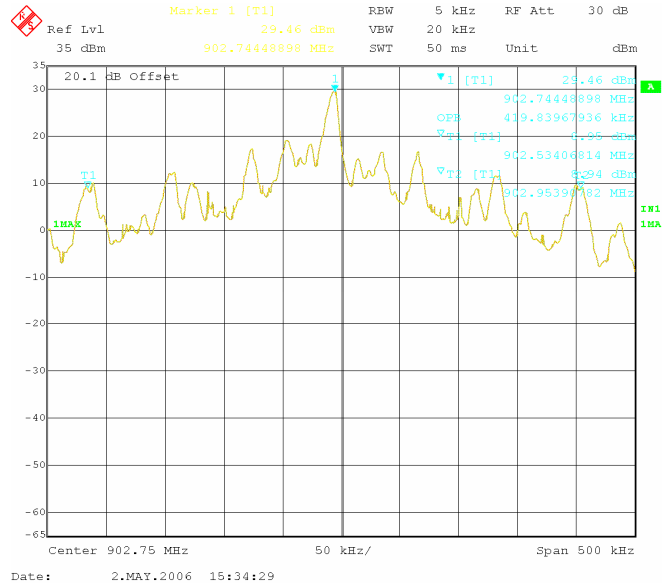


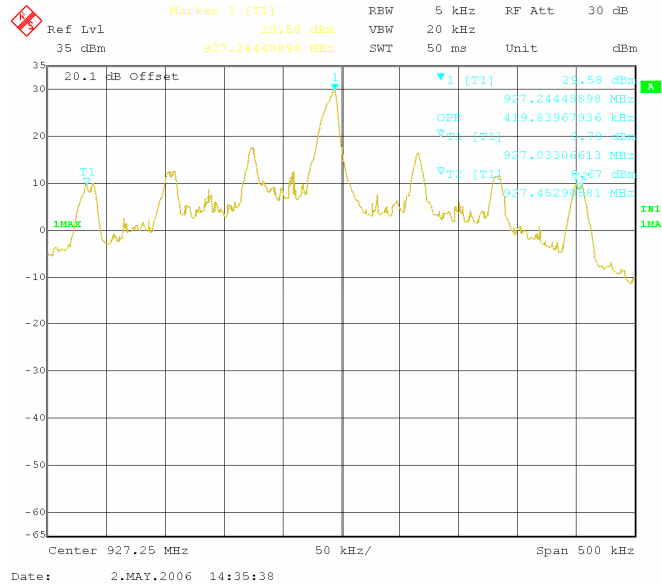
**Plot E: 99% Bandwidth (Mid) with ISOB protocol**



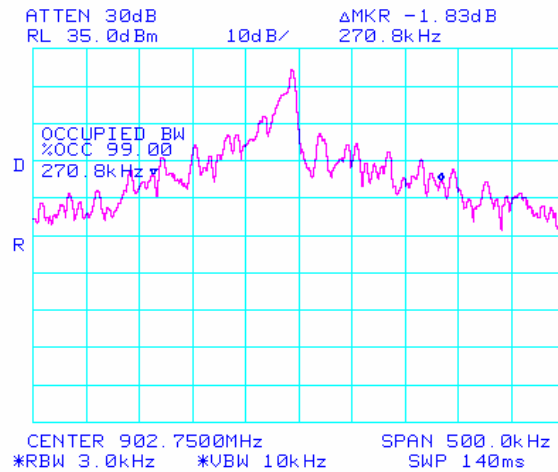
**Plot F: 99% Bandwidth (High) with ISOB protocol**







**Plot I: 99% Bandwidth (High) with CLASS-1 protocol**



**Plot J: 99% Bandwidth (Low) with CLASS-0 protocol**

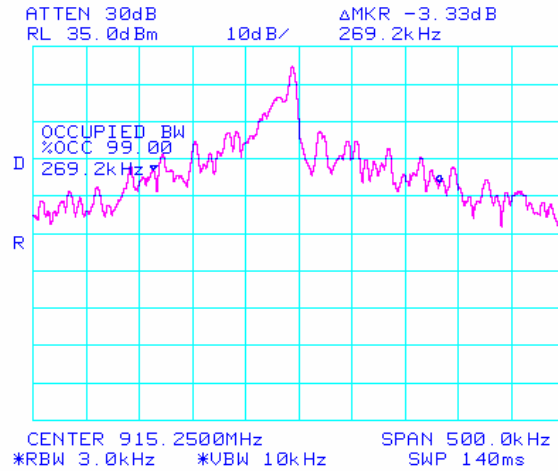


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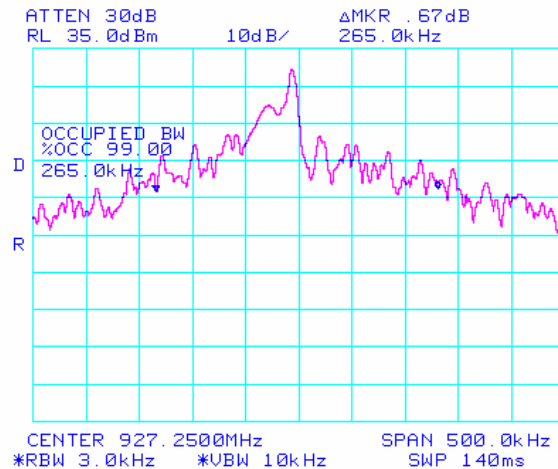
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Plot K: 99% Bandwidth (Mid) with CLASS-0 protocol



Plot L: 99% Bandwidth (High) with CLASS-0 protocol

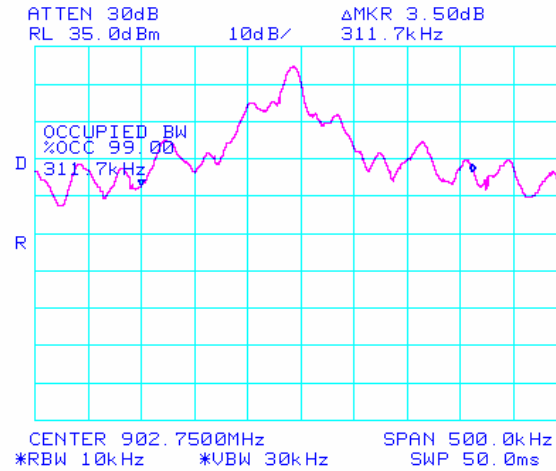


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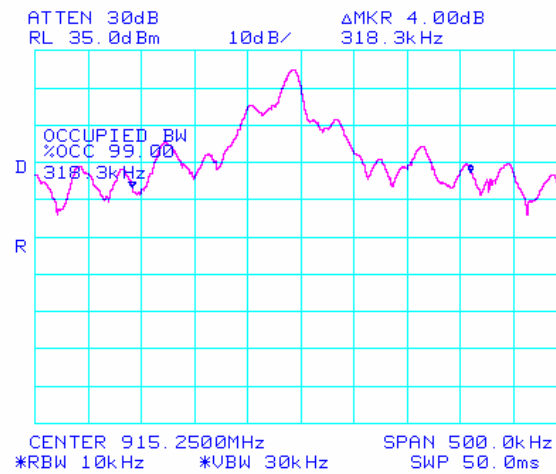
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To: 47 CFR 15.247:2005 & RSS-210 Issue  
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Plot M: 99% Bandwidth (Low) with EPC1.19 protocol



Plot N: 99% Bandwidth (Mid) with EPC1.19 protocol



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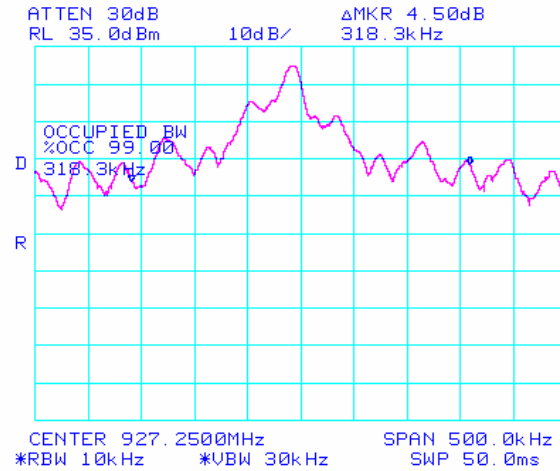
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**Plot O: 99% Bandwidth (High) with EPC1.19 protocol**

**Tested By:** Kerwinn Corpuz

**Date Tested:** 02 May and 02 June 2006



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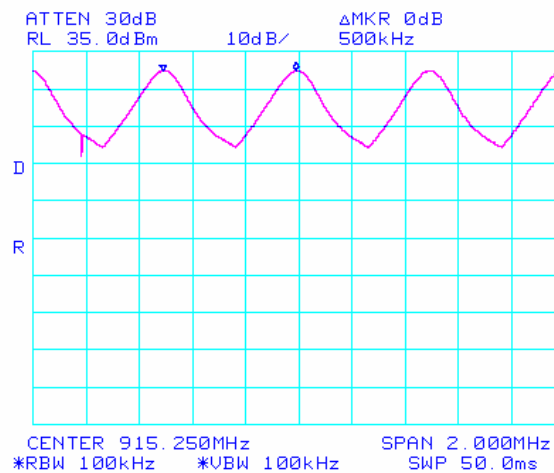
#### 4.2.3 Carrier Frequency Separation

Requirement(s): 47 CFR §15.247(a)(1) & RSS-210 (A8.1)

**Procedures:** The carrier frequency separation measurement was taken conducted using a spectrum analyzer.

**Results:**

Plot #	Carrier Frequency Separation (MHz)
16	0.500



Plot 16: Carrier Frequency Separation

Tested By: Kerwinn Corpuz

Date Tested: 02 May 2006



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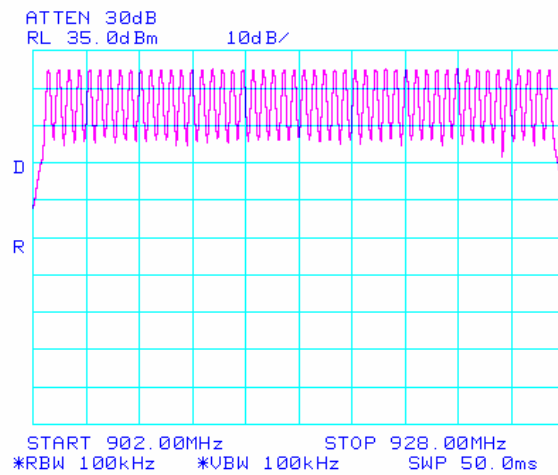
#### 4.2.4 Number of Hopping Channels

**Requirement(s):** 47 CFR §15.247(a)(1) & RSS-210 (A8.1)

**Procedures:** The number of hopping channels was measured conducted with a spectrum analyzer.

**Results:**

Plot #	Number of Hopping Channels
17	50



**Plot 17: Number of Hopping Channels**

**Tested By:** Kerwinn Corpuz

**Date Tested:** 02 May 2006

**SIEMIC**[www.siemic.com](http://www.siemic.com)**Title:** Applied Wireless ID Group, Inc.**FCCID:** OGSR32EA031**To:** 47 CFR 15.247:2005 & RSS-210 Issue 6:2005**Serial#** SL06042601-AWID-005/02**Issue Date** 19 July 2006**Page** 32 of 75

#### 4.2.5 Time of Occupancy

**Requirement(s):** 47 CFR §15.247(a)(1) & RSS-210 (A8.1)

The average time of occupancy shall not be greater than 0.4 second within a 20 second period.

**Procedures:** The time of occupancy was measured conducted with a spectrum analyzer.

**Results:**

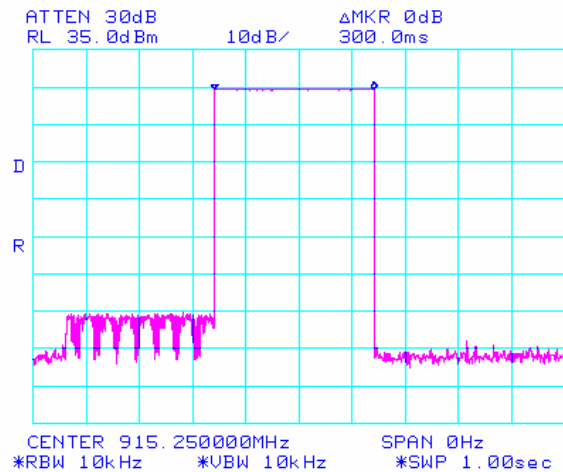
Plot #	Time of Occupancy (sec)
18 to 19	0.3978

Dwell time = 0.3 sec

Time between occupancy = 15.083 sec

Time of occupancy = period / time between occupancy \* dwell time

Therefore;  $20 / 15.083 * 0.3 = 0.3978$  second



**Plot 18: Dwell Time (1 of 2)**





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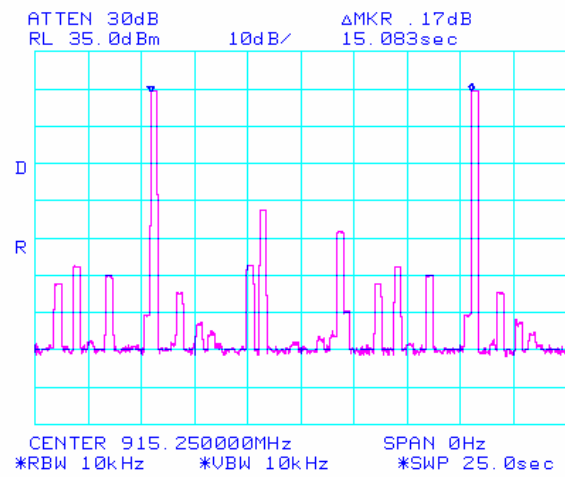
**FCCID:** OGSR32EA031

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6:2005

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**Plot 19: Time between Occupancy (2 of 2)**

**Tested By:** Kerwinn Corpuz

**Date Tested:** 02 May 2006

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#### 4.2.6 Peak Output Power

**Requirement(s):** 47 CFR §15.247(b) & RSS-210 (A8.4)

**Procedures:** The peak output power was measured conducted using a spectrum analyzer at low, mid, and hi channels. Limit = 1 watt (30dBm)

To maintain the output power below the limit, the software output attenuation index was set to 110.

Reference level offset to spectrum analyzer: 20.1 dB (attenuator + cable loss)

**Results:**

Plot #	Protocol	Channel	Channel Frequency (MHz)	Peak Power (dBm)
20	GEN-2	Low	902.75	29.83
21	GEN-2	Mid	915.25	29.83
22	GEN-2	High	927.25	29.83
23	ISOB	Low	902.75	29.65
24	ISOB	Mid	915.25	29.65
25	ISOB	High	927.25	29.70
26	CLASS-1	Low	902.75	29.65
27	CLASS-1	Mid	915.25	29.60
28	CLASS-1	High	927.25	29.70
29	CLASS-0	Low	902.75	29.67
30	CLASS-0	Mid	915.25	29.83
31	CLASS-0	High	927.25	29.83
32	EPC1.19	Low	902.75	29.67
33	EPC1.19	Mid	915.25	29.67
34	EPC1.19	High	927.25	29.67

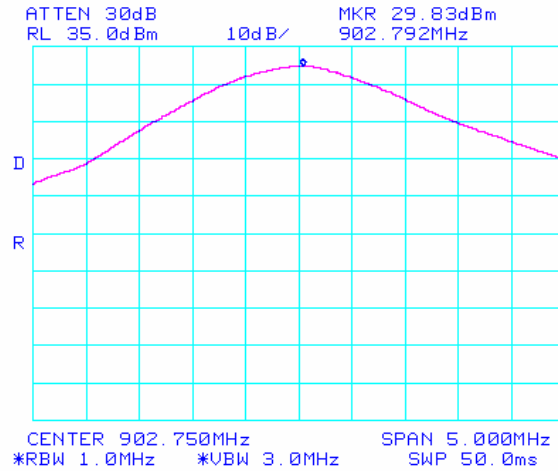


SIEMIC

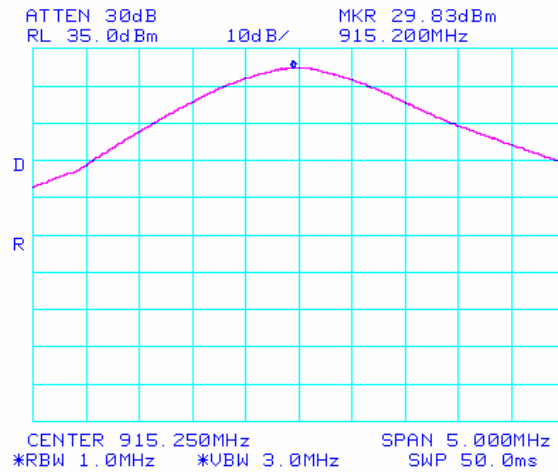
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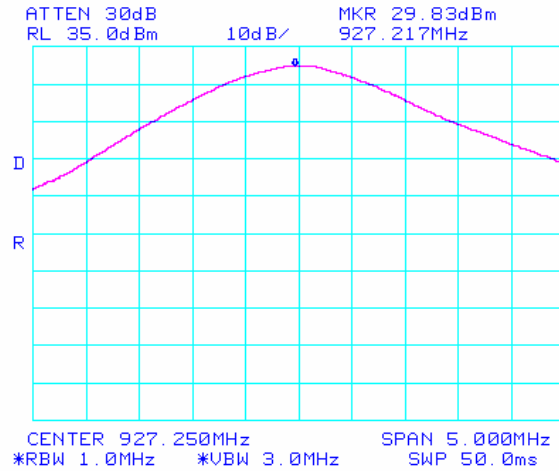
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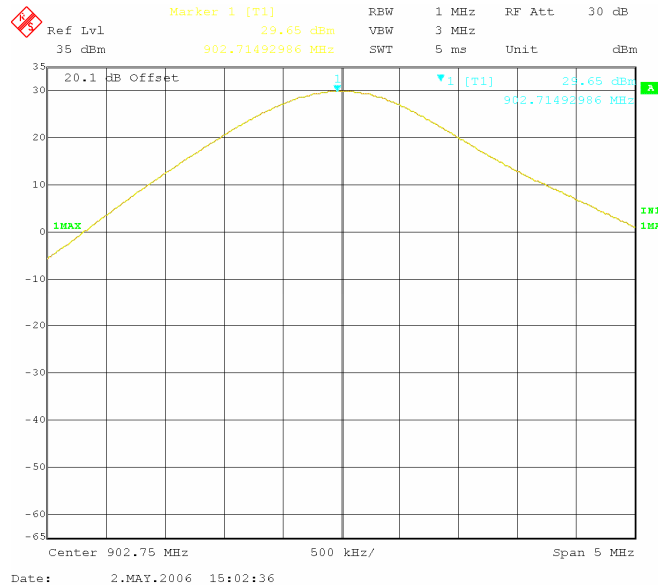
Plot 20: Peak Power (Low) with GEN-2 protocol



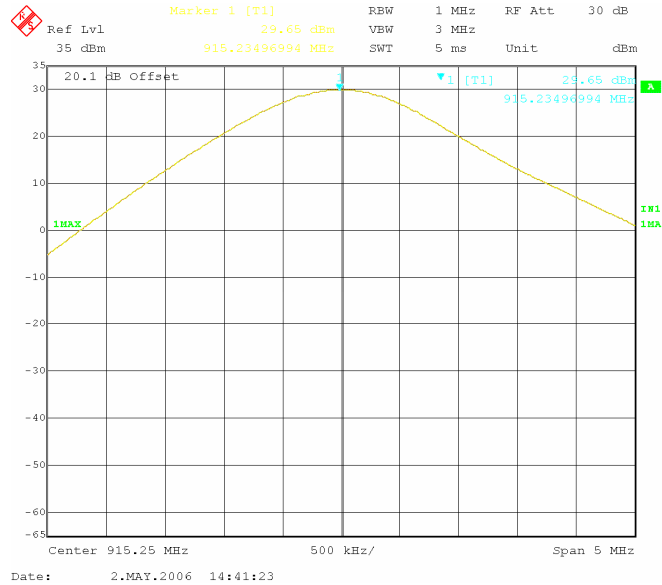
Plot 21: Peak Power (Mid) with GEN-2 protocol



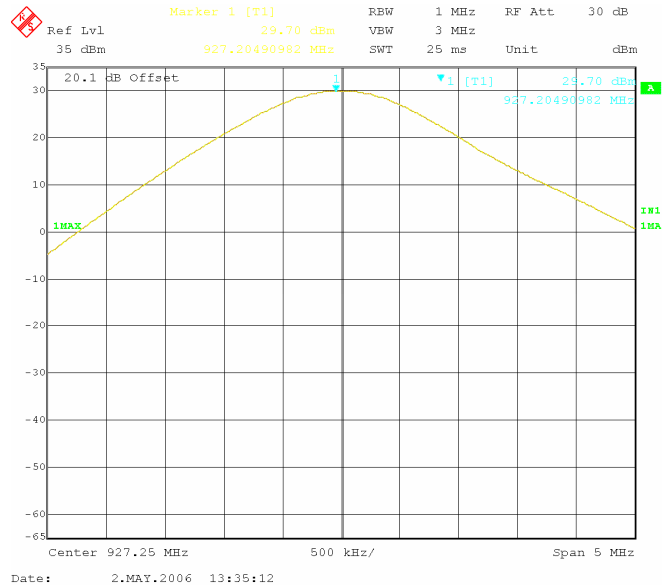
**Plot 22: Peak Power (High) with GEN-2 protocol**



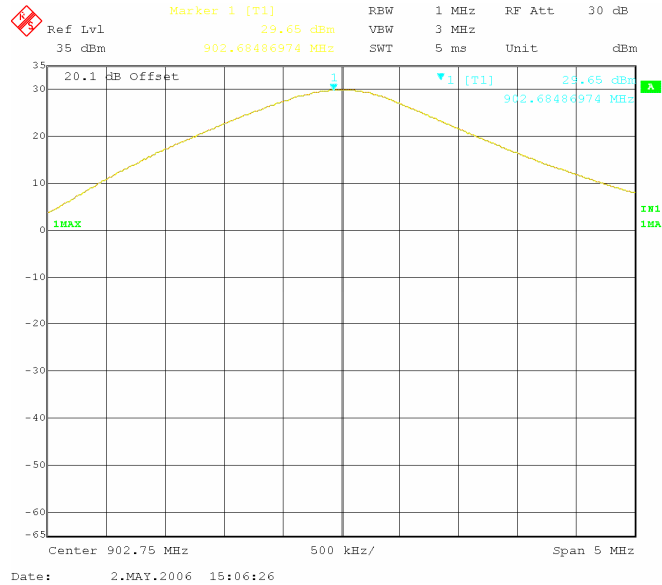
**Plot 23: Peak Power (Low) with ISOB protocol**



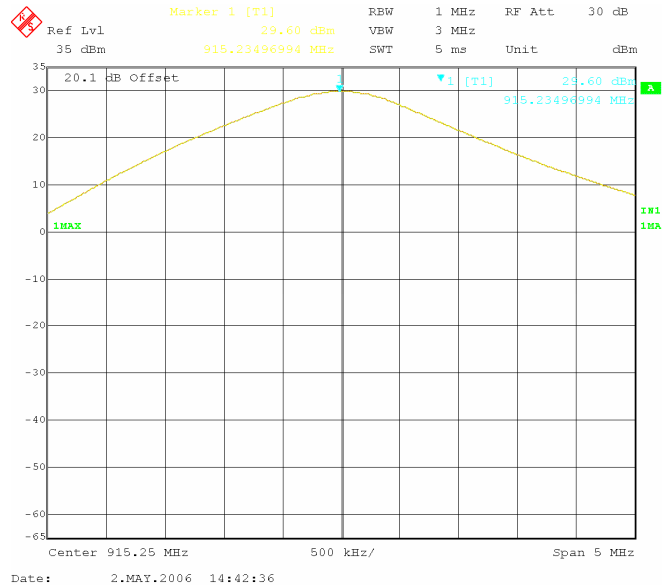
**Plot 24: Peak Power (Mid) with ISOB protocol**



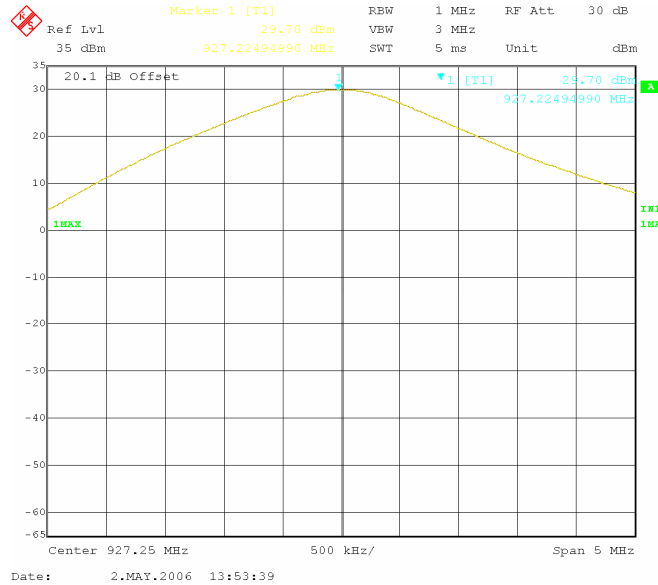
**Plot 25: Peak Power (High) with ISOB protocol**



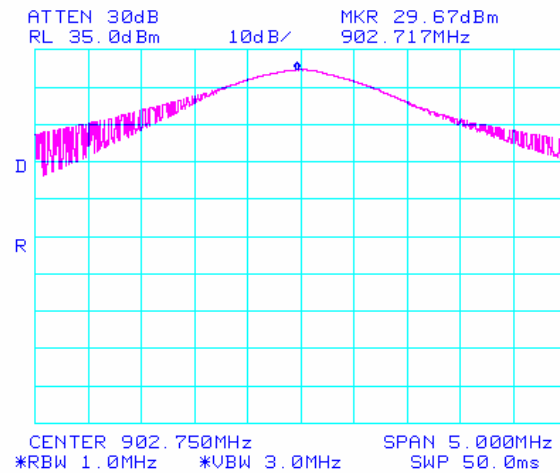
**Plot 26: Peak Power (Low) with CLASS-1 protocol**



**Plot 27: Peak Power (Mid) with CLASS-1 protocol**



**Plot 28: Peak Power (High) with CLASS-1 protocol**



**Plot 29: Peak Power (Low) with CLASS-0 protocol**

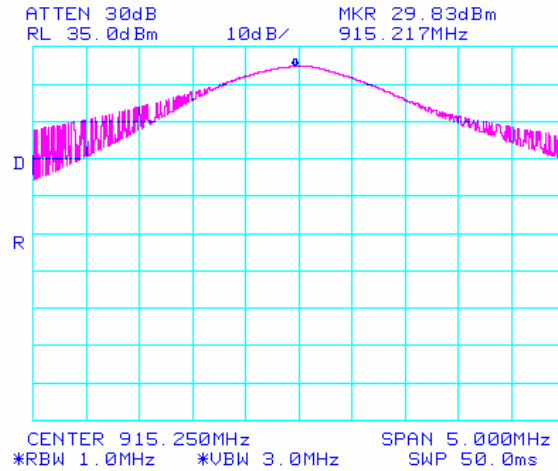


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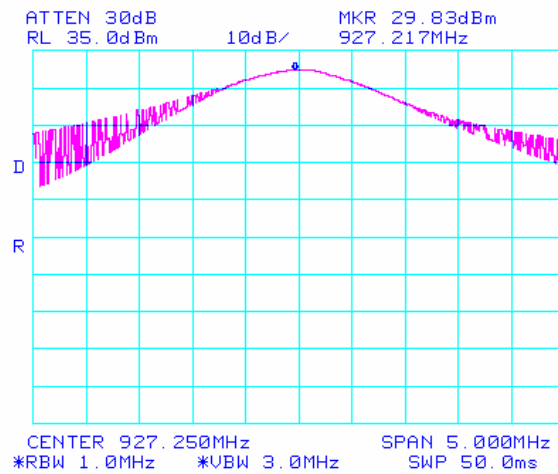
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Plot 30: Peak Power (Mid) with CLASS-0 protocol



Plot 31: Peak Power (High) with CLASS-0 protocol



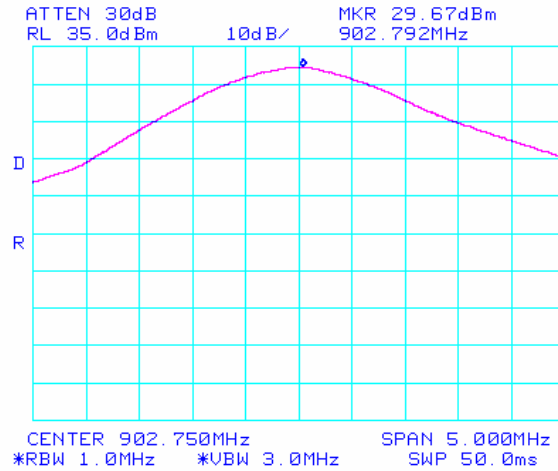


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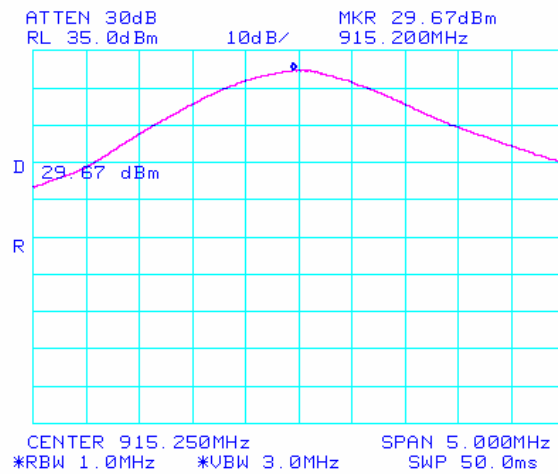
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Plot 32: Peak Power (Low) with EPC1.19 protocol



Plot 33: Peak Power (Mid) with EPC1.19 protocol



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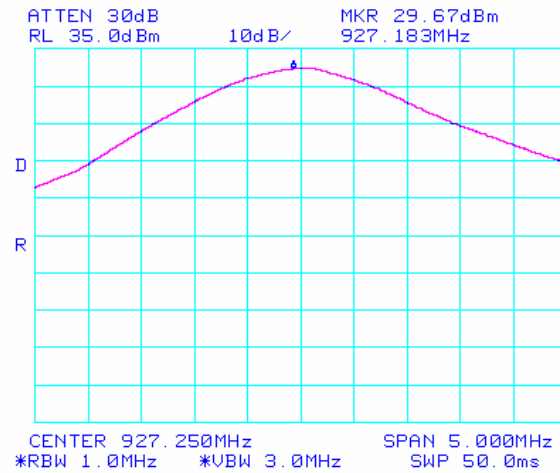
FCCID: OGSR32EA031

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Plot 34: Peak Power (High) with EPC1.19 protocol

Tested By: Kerwinn Corpuz

Date Tested: 02 May and 02 June 2006

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#### 4.2.7 Spurious Emissions at Antenna Terminals

**Requirement(s):** 47 CFR §15.247(d) & RSS-210 (A8.5)

**Procedures:** The conducted spurious emissions were measured conducted using a spectrum analyzer at low, mid, and hi channels. The limit is 20 dB attenuated from the peak value of the operating frequency. The spectrum was swept at least 15 times to capture all emissions.

**Results:**

Plots #	Protocol	Channel	Channel Frequency (MHz)	Pass/Fail
35	GEN-2	Low	902.75	Pass
36	GEN-2	Mid	915.25	Pass
37	GEN-2	High	927.25	Pass
38	ISOB	Low	902.75	Pass
39	ISOB	Mid	915.25	Pass
40	ISOB	High	927.25	Pass
41	CLASS-1	Low	902.75	Pass
42	CLASS-1	Mid	915.25	Pass
43	CLASS-1	High	927.25	Pass
44	CLASS-0	Low	902.75	Pass
45	CLASS-0	Mid	915.25	Pass
46	CLASS-0	High	927.25	Pass
47	EPC1.19	Low	902.75	Pass
48	EPC1.19	Mid	915.25	Pass
49	EPC1.19	High	927.25	Pass

**Note:** Emission over the limit line in the following plots is the fundamental.

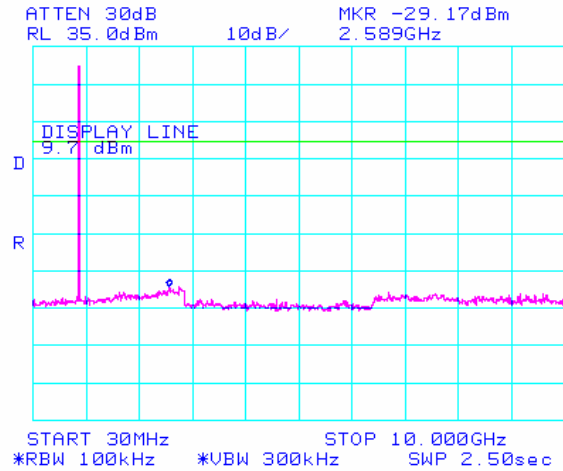


SIEMIC

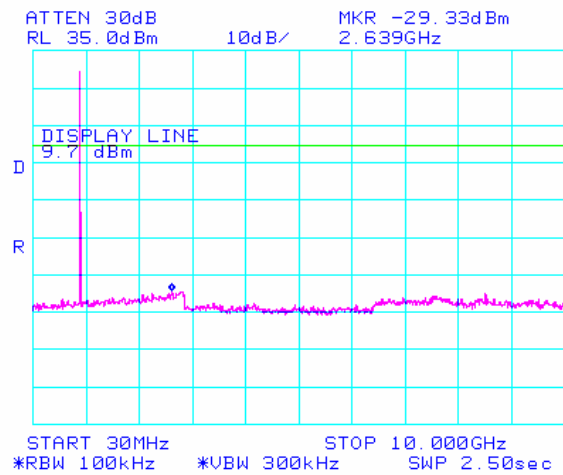
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Plot 35: Conducted Spurious Emissions (Low) with GEN-2 protocol



Plot 36: Conducted Spurious Emissions (Mid) with GEN-2 protocol

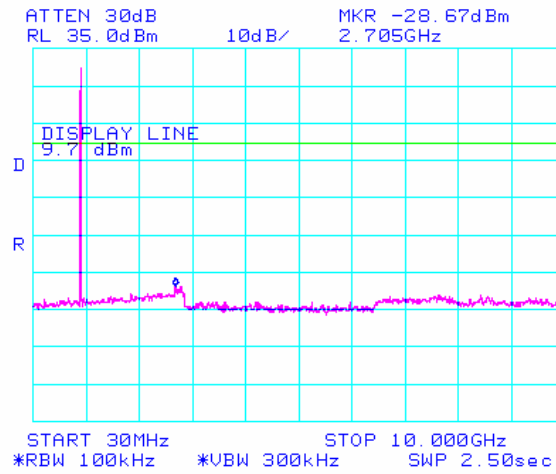


SIEMIC

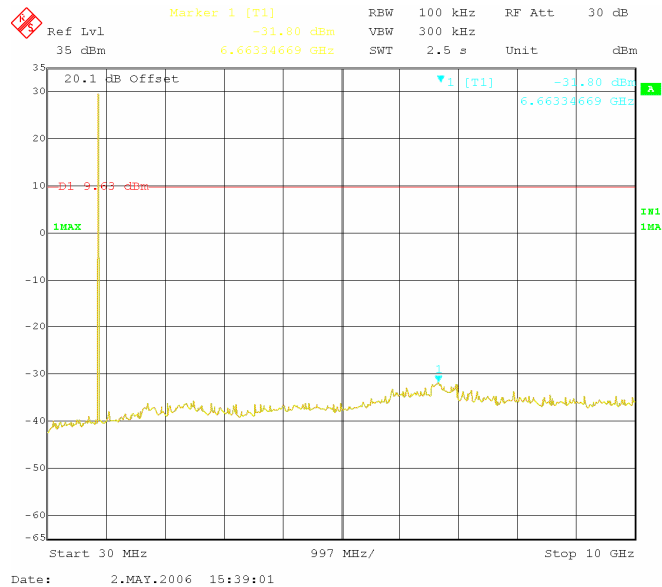
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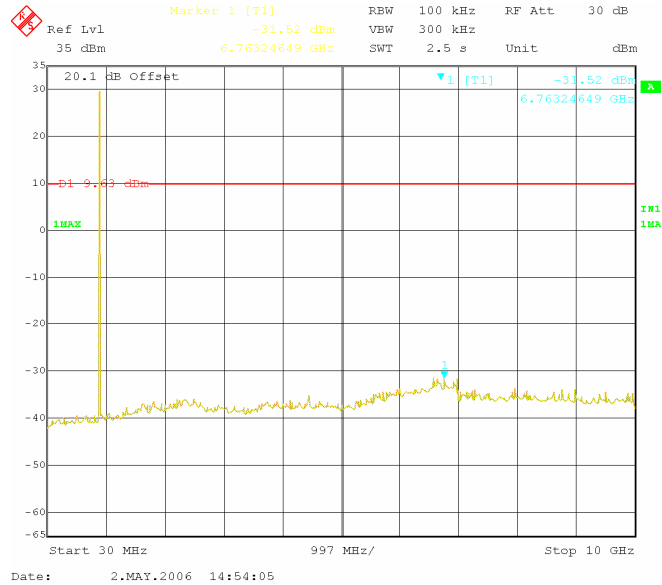
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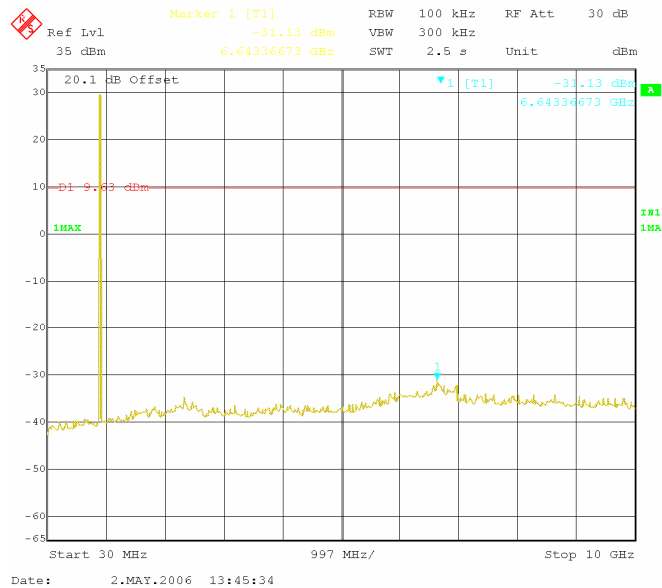
Plot 37: Conducted Spurious Emissions (High) with GEN-2 protocol



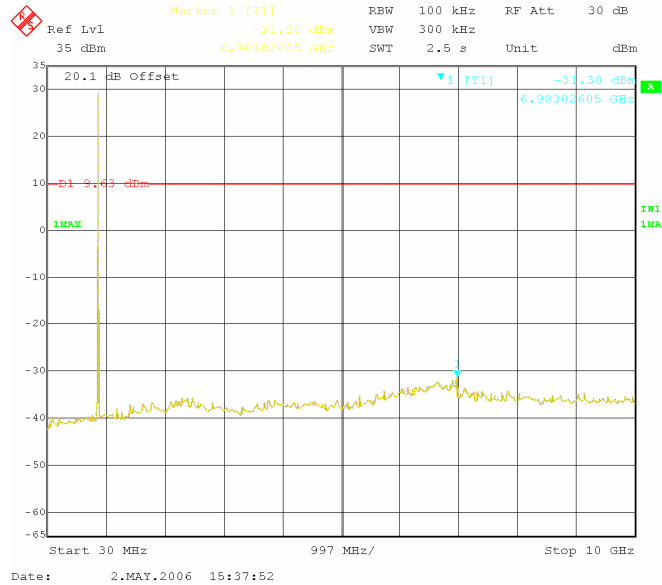
Plot 38: Conducted Spurious Emissions (Low) with ISOB protocol



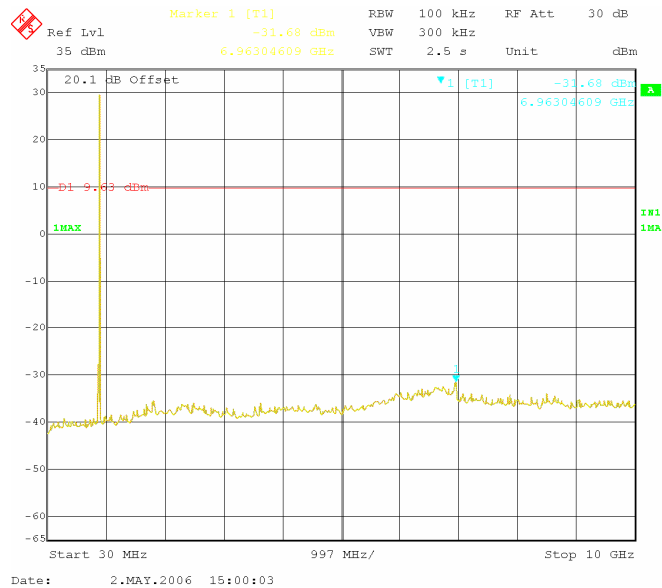
**Plot 39: Conducted Spurious Emissions (Mid) with ISOB protocol**



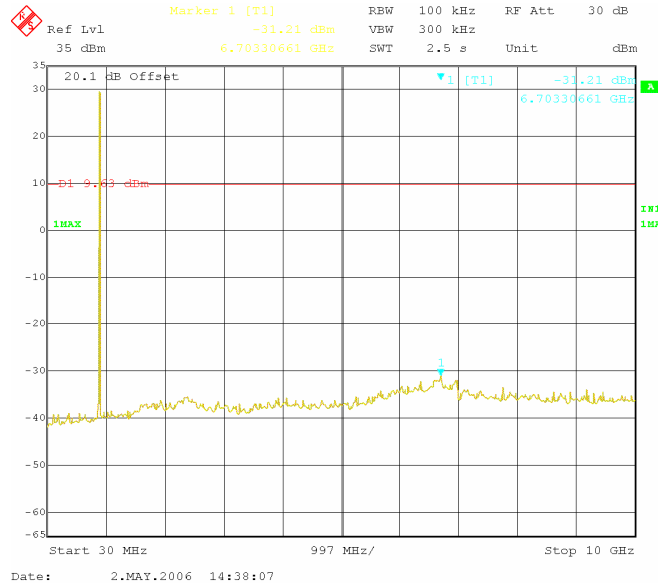
**Plot 40: Conducted Spurious Emissions (High) with ISOB protocol**



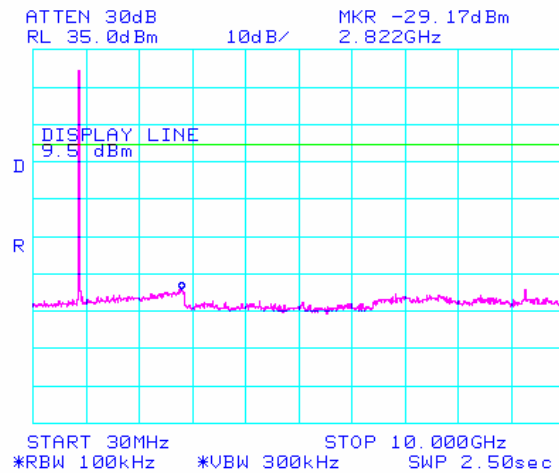
**Plot 41: Conducted Spurious Emissions (Low) with CLASS-1 protocol**



**Plot 42: Conducted Spurious Emissions (Mid) with CLASS-1 protocol**



**Plot 43: Conducted Spurious Emissions (High) with CLASS-1 protocol**



**Plot 44: Conducted Spurious Emissions (Low) with CLASS-0 protocol**



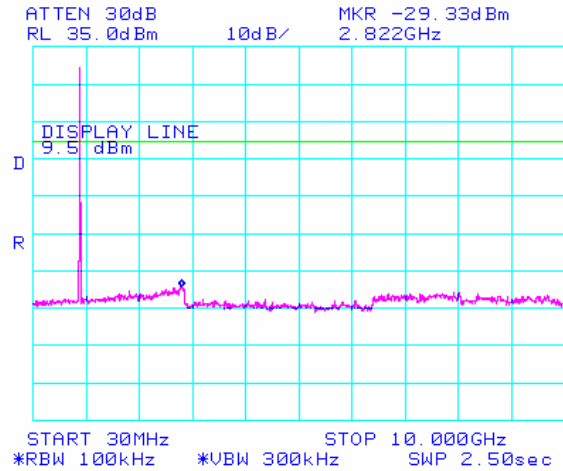


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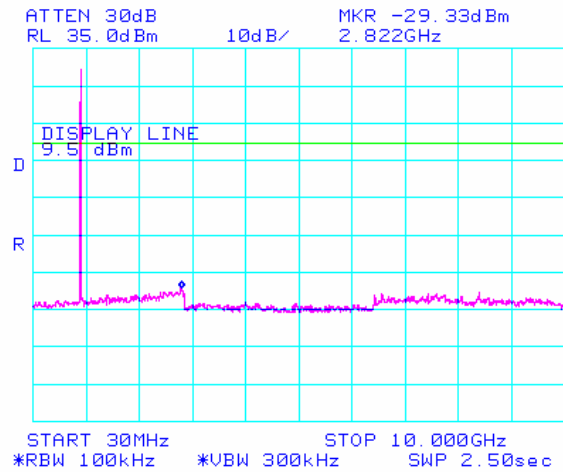
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Plot 45: Conducted Spurious Emissions (Mid) with CLASS-0 protocol



Plot 46: Conducted Spurious Emissions (High) with CLASS-0 protocol

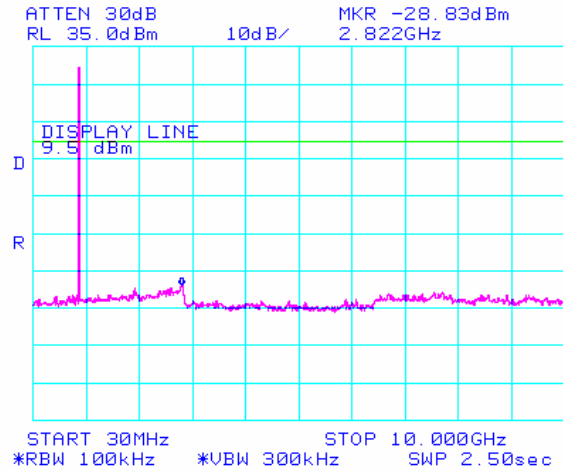


SIEMIC

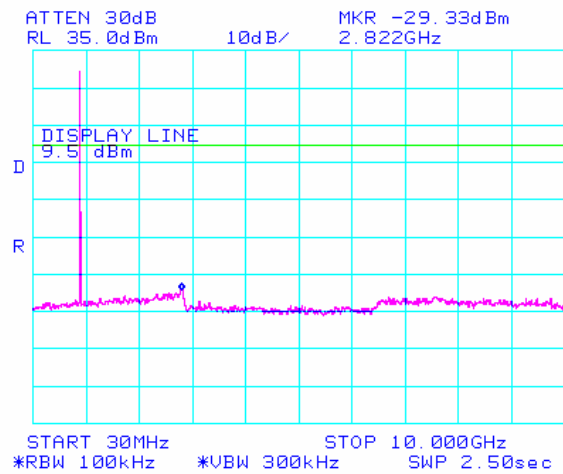
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Plot 47: Conducted Spurious Emissions (Low) with EPC1.19 protocol



Plot 48: Conducted Spurious Emissions (Mid) with EPC1.19 protocol



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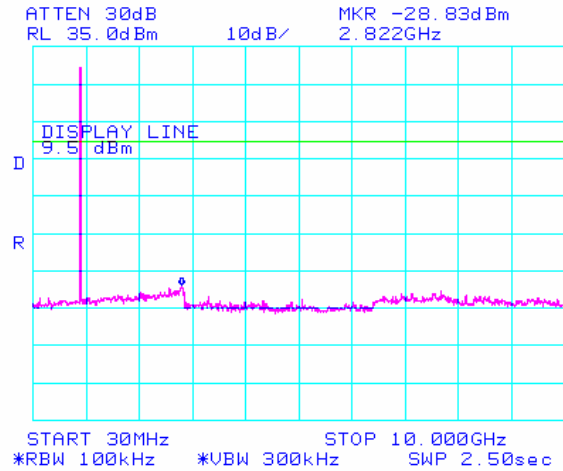
**FCCID:** OGSR32EA031

**To:** 47 CFR 15.247:2005 & RSS-210 Issue 6:2005

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**Plot 49: Conducted Spurious Emissions (High) with EPC1.19 protocol**

**Tested By:** Kerwinn Corpuz

**Date Tested:** 02 May and 02 June 2006

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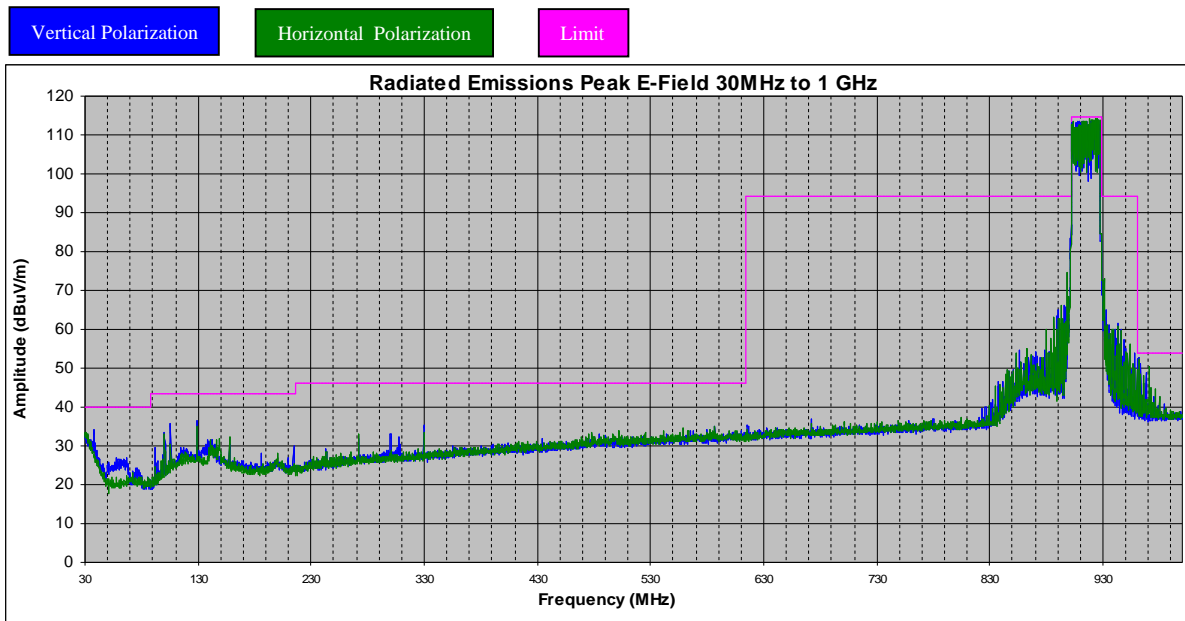
#### 4.2.8 Radiated Spurious Emissions < 1 GHz

**Requirement(s):** 47 CFR §15.247(d) & RSS-210 (A8.5)

**Procedures:** Radiated emissions were measured according to ANSI C63.4. The EUT was set to transmit at the highest output power. The EUT was set to frequency hopping mode. Preliminary test were made to five protocols with the worse case protocol (EPC C0) reported. Note that while hopping or single channel mode, the side skirts of the fundamental is the same emissions.

The limit is converted from microvolts/meter to decibel microvolts/meter.

Sample Calculation: Corrected Amplitude = Raw Amplitude(dBμV/m) + ACF(dB) + Cable Loss(dB)

**Results:**

**Radiated Emissions Plot**

Freq (MHz)	Peak Corrected at 3m (dBμV/m)	Limit (dBμV/m)	Delta (dB)	Polarization (V/H)
961.2	52.6	54	-1.4	V
961.59	52.4	54	-1.6	H
963.625	51.2	54	-2.8	V
971.48	50.5	54	-3.5	H

**Radiated Emissions Data****Tested By:** Kerwinn Corpuz**Date Tested:** 03 May and 05 June 2006

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#### 4.2.9 Radiated Spurious Emissions > 1 GHz

**Requirement(s):** 47 CFR §15.247(d) & RSS-210 (A8.5)

**Procedures:** Equipment was setup in a semi-anechoic chamber. For measurements above 1 GHz an average measurement was taken with a 10Hz video bandwidth. Peak measurement was taken with 1 MHz BW. The EUT was tested at low, mid and high with the highest output power. The EUT was tested with five protocols with the worse case protocol (EPC C0) reported. Investigated up to 10<sup>th</sup> harmonic of the operating frequency.

Sample Calculation:

EUT Field Strength = Raw Amplitude(dBμV/m) – Amplifier Gain(dB) + Antenna Factor(dB) + Cable Loss(dB) + Filter Attenuation(dB, if used)

**Results:** **$f_o = 0.90275$  GHz (Low)**

Frequency	Azimuth	Detector	Antenna Polarization	Antenna Height	Raw Amplitude @ 3m	Pre Amp	ACF	Cable Loss	Corrected Amplitude @ 3m	Limit @ 3m	Delta
(GHz)	(degrees)	(Pk/Avg)	(V/H)	(m)	(dBμV/m)	(dB)	(dB)	(dB)	(dBμV/m)	(dBμV/m)	(dB)
1.8055	10	Pk	V	1	52.3	32.20	26.92	1.84	48.86	74	-25.14
1.8055	10	Avg	V	1	41	32.20	26.92	1.84	37.56	54	-16.44
1.8055	-	-	H	-	-	-	-	-	-	-	-
2.70825	-	-	-	-	-	-	-	-	-	-	-
3.611	185	Pk	V	1	51.9	33.34	31.63	2.65	52.83	74	-21.17
3.611	185	Avg	V	1	42.3	33.34	31.63	2.65	43.23	54	-10.77
3.611	-	-	H	-	-	-	-	-	-	-	-
4.51375	-	-	-	-	-	-	-	-	-	-	-

Note: 1.8055 GHz, 3.611 GHz (horizontal polarization), 2.70825 GHz and emissions after 4<sup>th</sup> harmonic measured noise floor.

 **$f_o = 0.91525$  GHz (Mid)**

Frequency	Azimuth	Detector	Antenna Polarization	Antenna Height	Raw Amplitude @ 3m	Pre Amp	ACF	Cable Loss	Corrected Amplitude @ 3m	Limit @ 3m	Delta
(GHz)	(degrees)	(Pk/Avg)	(V/H)	(m)	(dBμV/m)	(dB)	(dB)	(dB)	(dBμV/m)	(dBμV/m)	(dB)
1.8305	135	Pk	V	1	51.8	32.21	27.04	1.86	48.49	74	-25.51
1.8305	135	Avg	V	1	40.5	32.21	27.04	1.86	37.19	54	-16.81
1.8305	-	-	H	-	-	-	-	-	-	-	-
2.74575	-	-	-	-	-	-	-	-	-	-	-
3.661	190	Pk	V	1	52.1	33.42	31.72	2.73	53.14	74	-20.86
3.661	190	Avg	V	1	43.1	33.42	31.72	2.73	44.14	54	-9.86
3.661	-	-	H	-	-	-	-	-	-	-	-
4.57625	-	-	-	-	-	-	-	-	-	-	-

Note: 1.8305 GHz, 3.661 GHz (horizontal polarization), 2.74575 GHz and emissions after 4<sup>th</sup> harmonic measured noise floor.

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Frequency	Azimuth	Detector	Antenna Polarization	Antenna Height	Raw Amplitude @ 3m	Pre Amp	ACF	Cable Loss	Corrected Amplitude @ 3m	Limit @ 3m	Delta
(GHz)	(degrees)	(Pk/Avg)	(V/H)	(m)	(dBuV/m)	(dB)	(dB)	(dB)	(dBuV/m)	(dBuV/m)	(dB)
1.8545	125	Pk	V	1	53.9	32.23	27.16	1.88	50.71	74	-23.29
1.8545	125	Avg	V	1	44.5	32.23	27.16	1.88	41.31	54	-12.69
1.8545	-	-	H	-	-	-	-	-	-	-	-
2.78175	-	-	-	-	-	-	-	-	-	-	-
3.709	185	Pk	V	1	51.3	33.49	31.82	2.83	52.45	74	-21.55
3.709	185	Avg	V	1	40	33.49	31.82	2.83	41.15	54	-12.85
3.709	-	-	H	-	-	-	-	-	-	-	-
4.63625	-	-	-	-	-	-	-	-	-	-	-

Note: 1.8545 GHz, 3.709 GHz (horizontal polarization), 2.78175 GHz and emissions after 4<sup>th</sup> harmonic measured noise floor.

**Tested By: Kerwinn Corpuz****Date Tested: 04 May and 05 June 2006**

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#### 4.2.10 Radiated Emissions – Band Edge

**Requirement(s):** 47 CFR §15.247(d) & RSS-210 (A8.5)

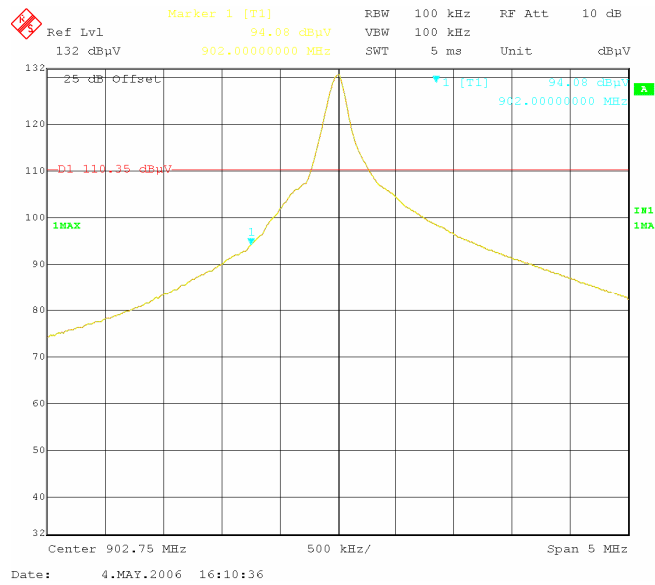
**Procedures:** Radiated emissions were measured according to ANSI C63.4. Equipment was tested with six protocols at low and high channel. An offset was set to spectrum analyzer with 25 dB. The limit is 20 dB attenuated from the peak value of the operating frequency.

Sample Calculation:

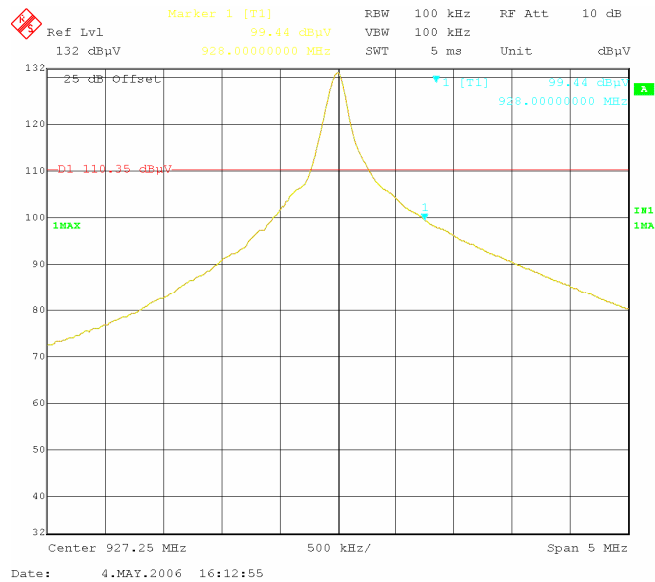
EUT Field Strength = Raw Amplitude(dBμV/m) + Antenna Factor(dB) + Cable Loss(dB)

**Results:**

Plot #	Freq (MHz)	Peak Corrected at 3m (dBμV/m)	Limit (dBμV/m)	Delta (dB)	Polarization (V/H)	Protocol
50	902	94.08	110.35	-16.27	V	GEN-2
51	928	99.44	110.35	-10.91	V	GEN-2
52	902	94.79	111.3	-16.51	H	GEN-2
53	928	99.98	111.3	-11.32	H	GEN-2
54	902	95.34	110.35	-15.01	V	ISOB
55	928	97.97	110.35	-12.38	V	ISOB
56	902	96.71	111.3	-14.59	H	ISOB
57	928	100.09	111.3	-11.21	H	ISOB
58	902	102.41	110.35	-7.94	V	CLASS-1
59	928	104.24	110.35	-6.11	V	CLASS-1
60	902	103.68	111.3	-7.62	H	CLASS-1
61	928	105.94	111.3	-5.36	H	CLASS-1
62	902	98.99	110.35	-11.36	V	CLASS-0
63	928	98.42	110.35	-11.93	V	CLASS-0
64	902	99.71	111.3	-11.59	H	CLASS-0
65	928	99.76	111.3	-11.54	H	CLASS-0
66	902	93.29	110.35	-17.06	V	EPC1.19
67	928	98.07	110.35	-12.28	V	EPC1.19
68	902	94.06	111.3	-17.24	H	EPC1.19
69	928	99.65	111.3	-11.65	H	EPC1.19

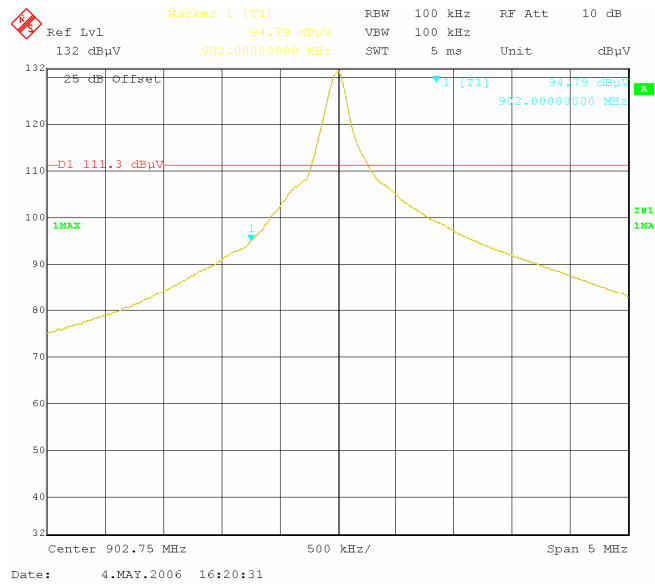


**Plot 50: Lower Edge (Vertical) with GEN-2 protocol**

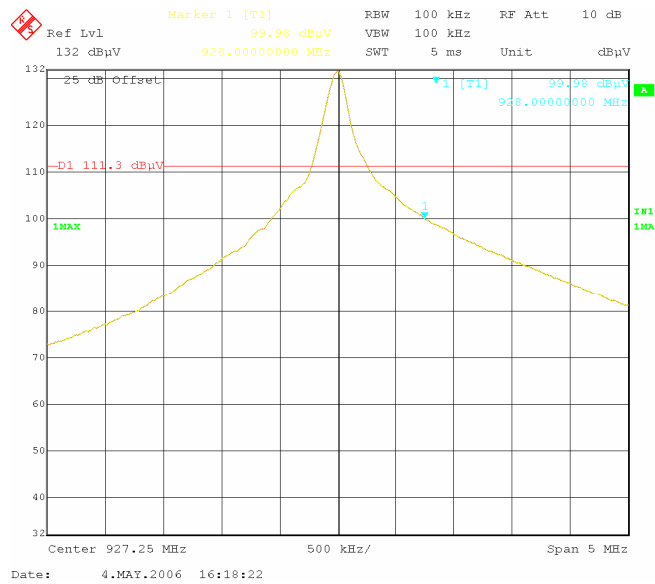


**Plot 51: Upper Edge (Vertical) with GEN-2 protocol**

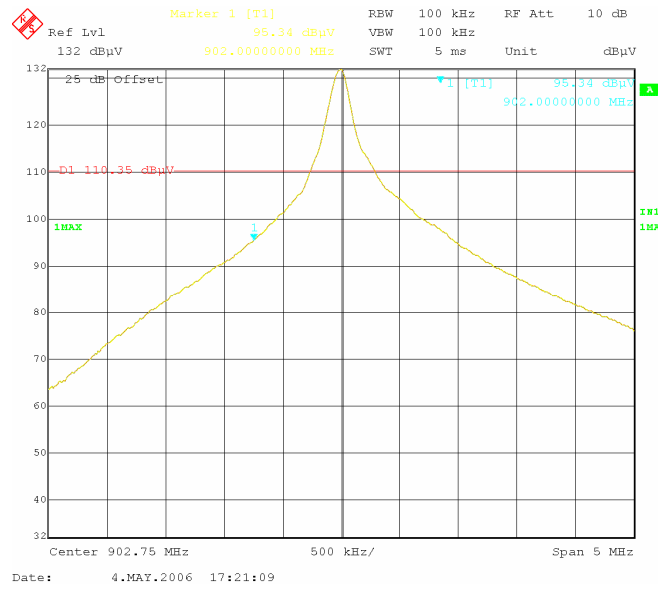




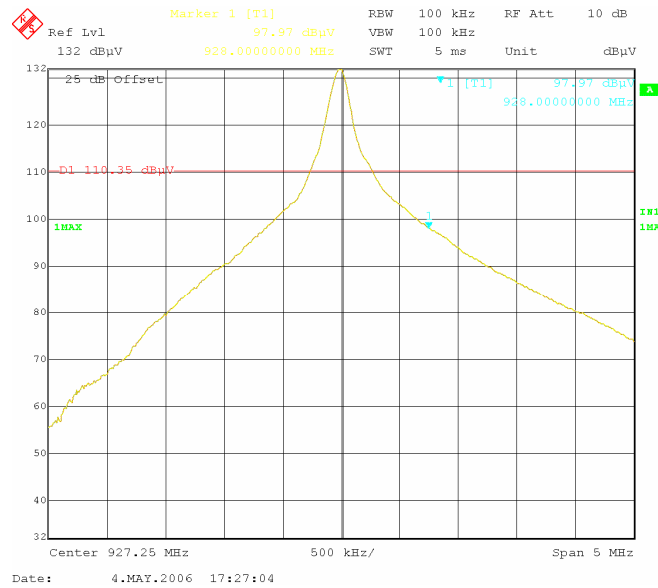
**Plot 52: Lower Edge (Horizontal) with GEN-2 protocol**



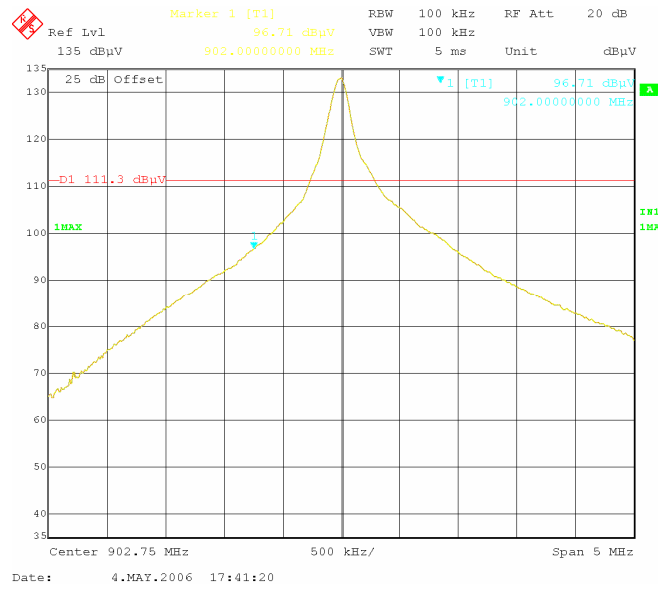
**Plot 53: Upper Edge (Horizontal) with GEN-2 protocol**



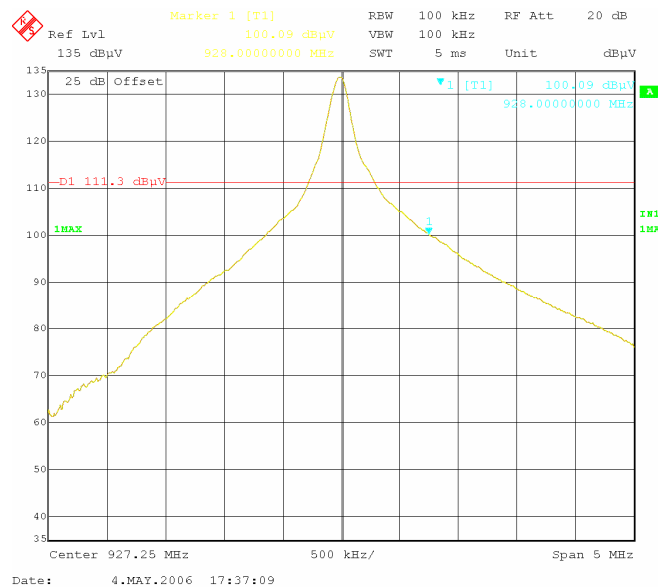
**Plot 54: Lower Edge (Vertical) with ISOB protocol**



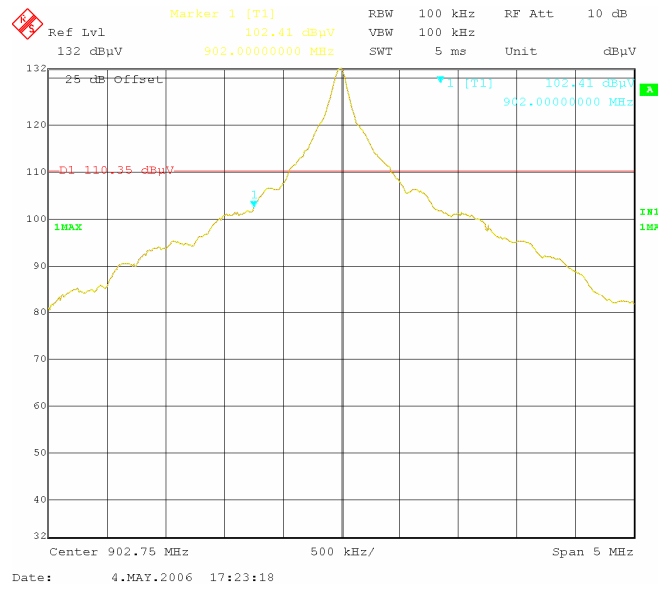
**Plot 55: Upper Edge (Vertical) with ISOB protocol**



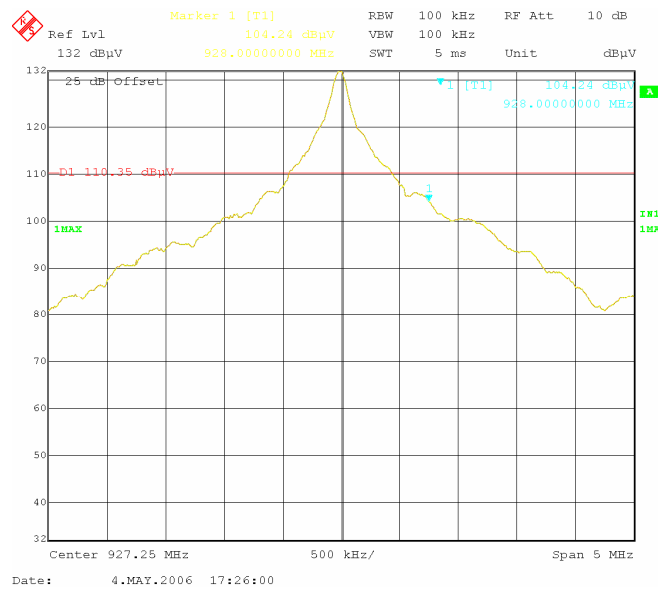
**Plot 56: Lower Edge (Horizontal) with ISOB protocol**



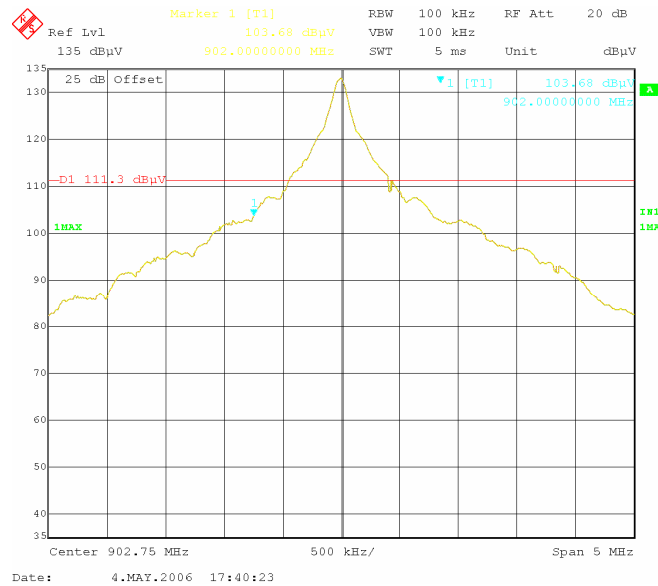
**Plot 57: Upper Edge (Horizontal) with ISOB protocol**



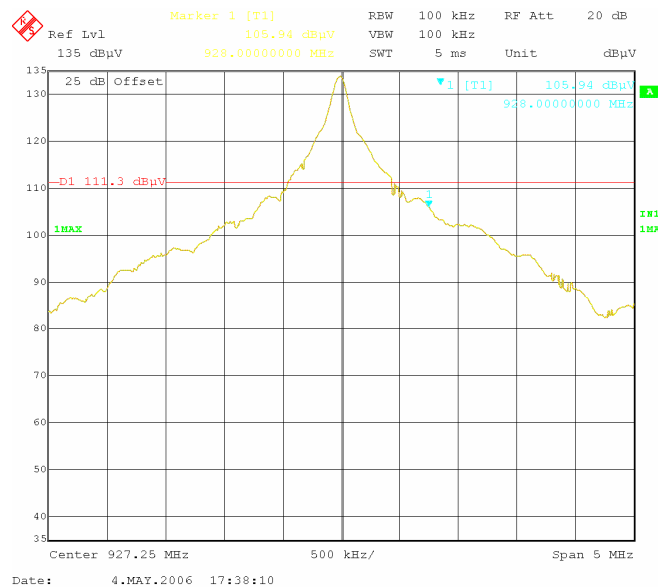
**Plot 58: Lower Edge (Vertical) with CLASS-1 protocol**



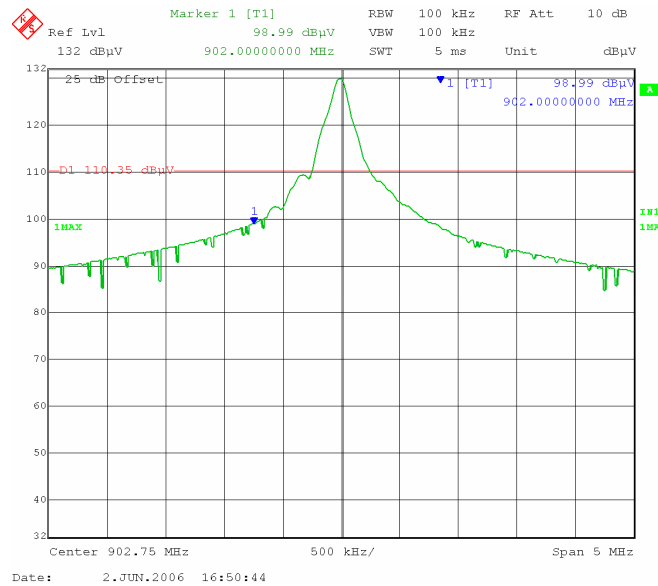
**Plot 59: Upper Edge (Vertical) with CLASS-1 protocol**



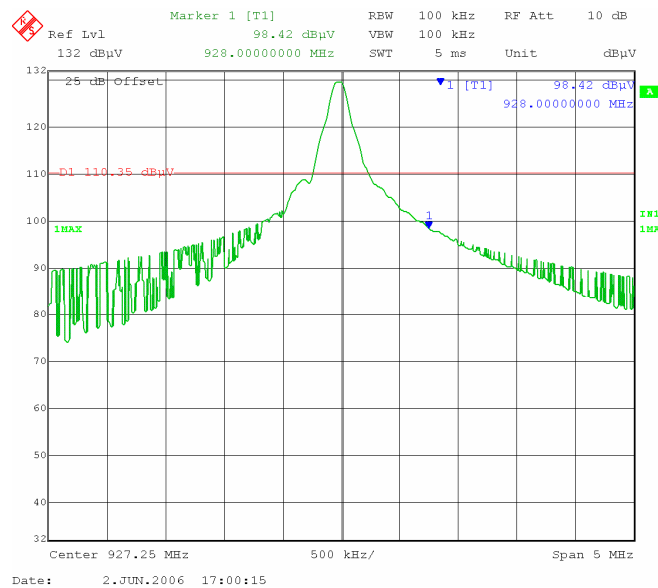
**Plot 60: Lower Edge (Horizontal) with CLASS-1 protocol**



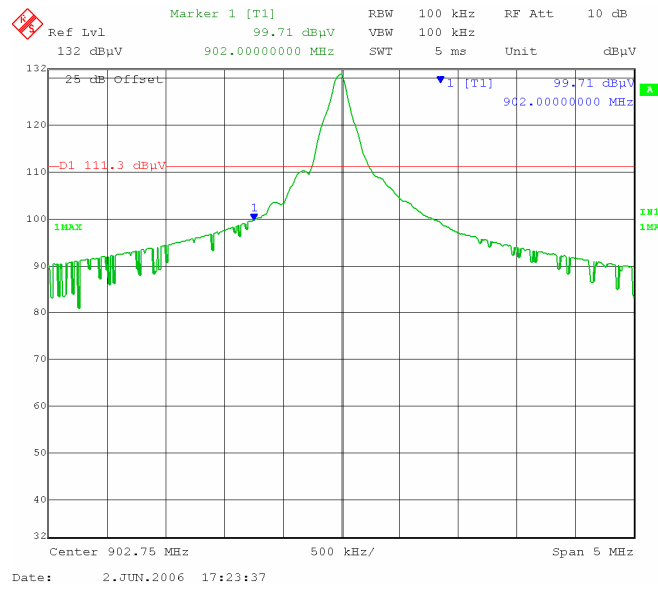
**Plot 61: Upper Edge (Horizontal) with CLASS-1 protocol**



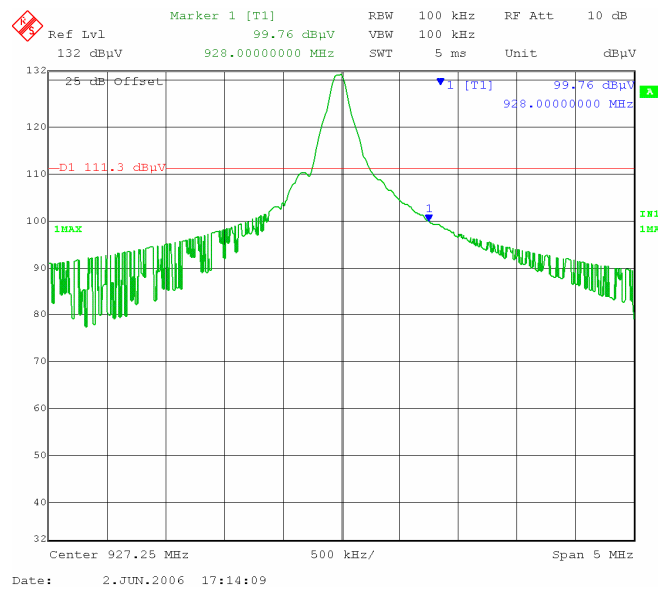
**Plot 62: Lower Edge (Vertical) with CLASS-0 protocol**



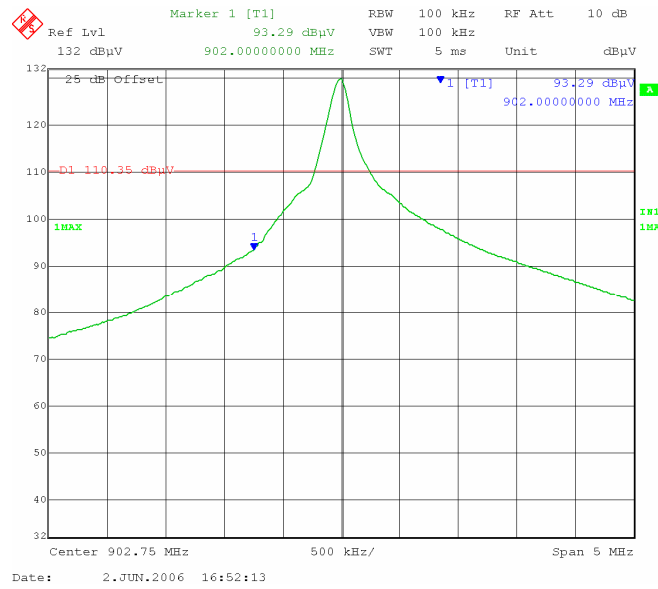
**Plot 63: Upper Edge (Vertical) with CLASS-0 protocol**



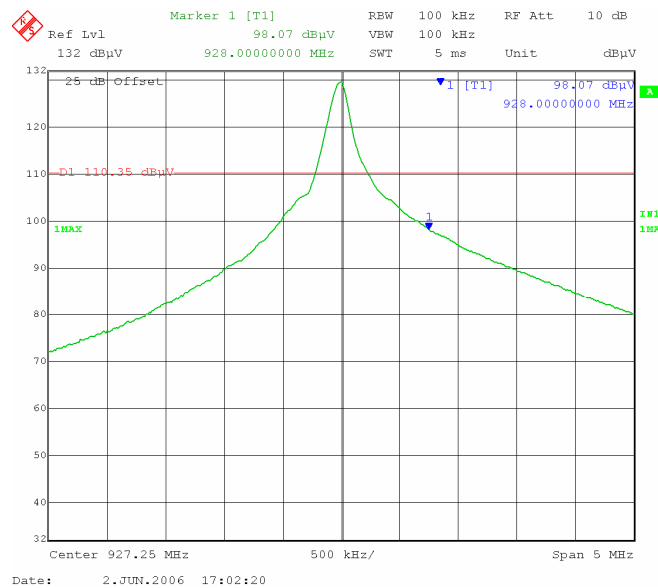
**Plot 64: Lower Edge (Horizontal) with CLASS-0 protocol**



**Plot 65: Upper Edge (Horizontal) with CLASS-0 protocol**

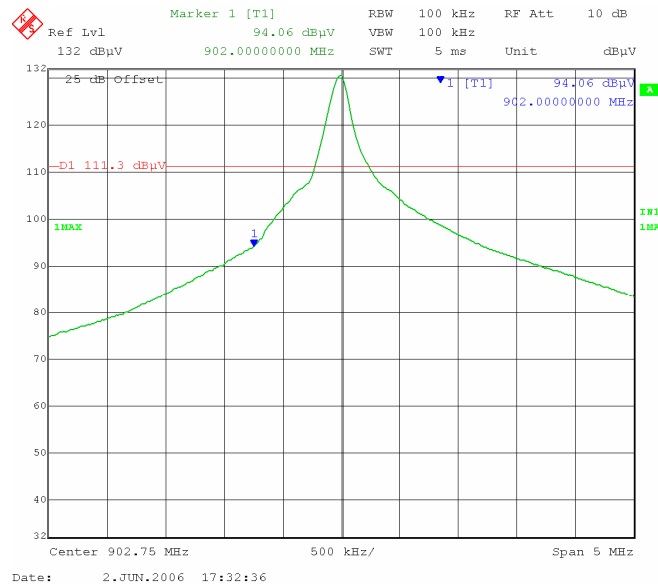


**Plot 66: Lower Edge (Vertical) with EPC1.19 protocol**

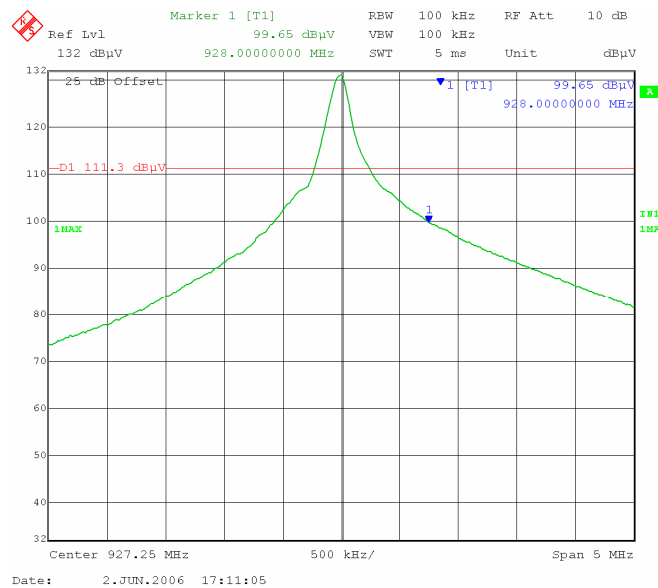


**Plot 67: Upper Edge (Vertical) with EPC1.19 protocol**





**Plot 68: Lower Edge (Horizontal) with EPC1.19 protocol**



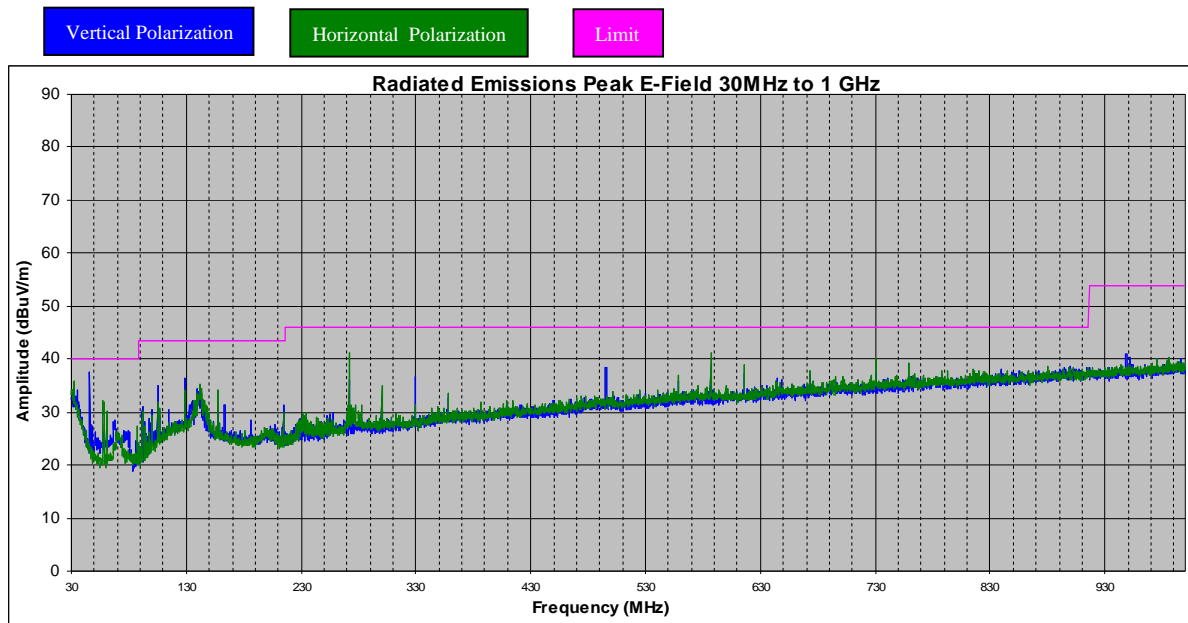
**Plot 69: Upper Edge (Horizontal) with EPC1.19 protocol**

**Tested By:** Kerwinn Corpuz

**Date Tested:** 04 May and 02 June 2006

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#### 4.2.11 Receiver Spurious Emissions

**Requirement(s):** RSS-GEN (4.8)**Procedures:** Radiated emissions were measured according to RSS-GEN. Measurement was taken with spectrum analyzer.Sample Calculation: Corrected Amplitude = Raw Amplitude(dB $\mu$ V/m) + ACF(dB) + Cable Loss(dB)**Results:**

**Radiated Emissions Plot**

Freq (MHz)	Peak Corrected at 3m (dB $\mu$ V/m)	Limit (dB $\mu$ V/m)	Delta (dB)
46.20	37.55	40	-2.45
32.81	35.74	40	-4.26
271.82	41.18	46	-4.82
586.78	41.05	46	-4.95
730.15	40.16	46	-5.84

**Radiated Emissions Data****Tested By:** Kerwinn Corpuz**Date Tested:** 03 May and 06 June 2006

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## **5 TEST INSTRUMENTATION**

### **5.1 TEST INSTRUMENTATION**

<b>Instrument</b>	<b>Manufacturer</b>	<b>Model</b>	<b>CAL Due Date</b>
Spectrum Analyzer	HP	8568B	04/26/2007
Quasi-Peak Adapter	HP	85650A	04/26/2007
RF Pre-Selector	HP	85685A	04/26/2007
Spectrum Analyzer	HP	8564E	12/29/2006
Power Meter	HP	437B	04/26/2007
Power Sensor	HP	8485A	04/26/2007
Antenna	Emco	3115	07/12/2006
Antenna	Emco	3115	See Note
Signal Generator	Wiltron	68169B	04/26/2007
Chamber	Lingren	3m	08/21/2006
Pre-Amplifier	HP	8449	07/19/2006
DMM	Fluke	73III	07/04/2006
Variac	KRM	AEEC-2090	See Note
Environment Chamber	TestEquity	1007H	10/27/2006
DMM	Fluke	51II	See Note
900 MHz Notch Filter	AWID	N/A	See Note
4GHz High Pass Filter	LORCH Microwave	4HPD-X4000-3R	See Note

Note: Functional Verification

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## **APPENDIX A: EUT TEST CONDITIONS**

The following is the description of supporting equipment and details of cables used with the EUT.

Equipment Description (Including Brand Name)	Cable Description
AWID MPR-3014WF	1. Power cord 2. MMCX to reversed polarity TNC cable

EUT Description	: RFID Reader Module
Model No	: MPR-3014WF
Serial No	: none

The following is the description of how the EUT is exercised during testing.

Test	Description Of Operation
	The EUT was controlled via PC to enter test modes necessary to complete the testing.



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## **APPENDIX B: EXTERNAL PHOTOS**

See Attachment



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## **APPENDIX C: CIRCUIT/BLOCK DIAGRAMS**

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## **APPENDIX D: INTERNAL PHOTOS**

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## **APPENDIX E: PRODUCT DESCRIPTION**

Detail description of this product is shown in the User's Guide.





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## **APPENDIX F: FCC LABEL LOCATION**

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## **APPENDIX G: USER MANUAL**

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**END OF REPORT**